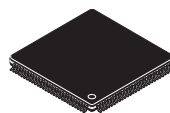




## MCF52277



LQFP-176  
24 mm x 24 mm



MAPBGA-196  
15mm x 15mm

# MCF5227x ColdFire® Microprocessor Data Sheet

### Features

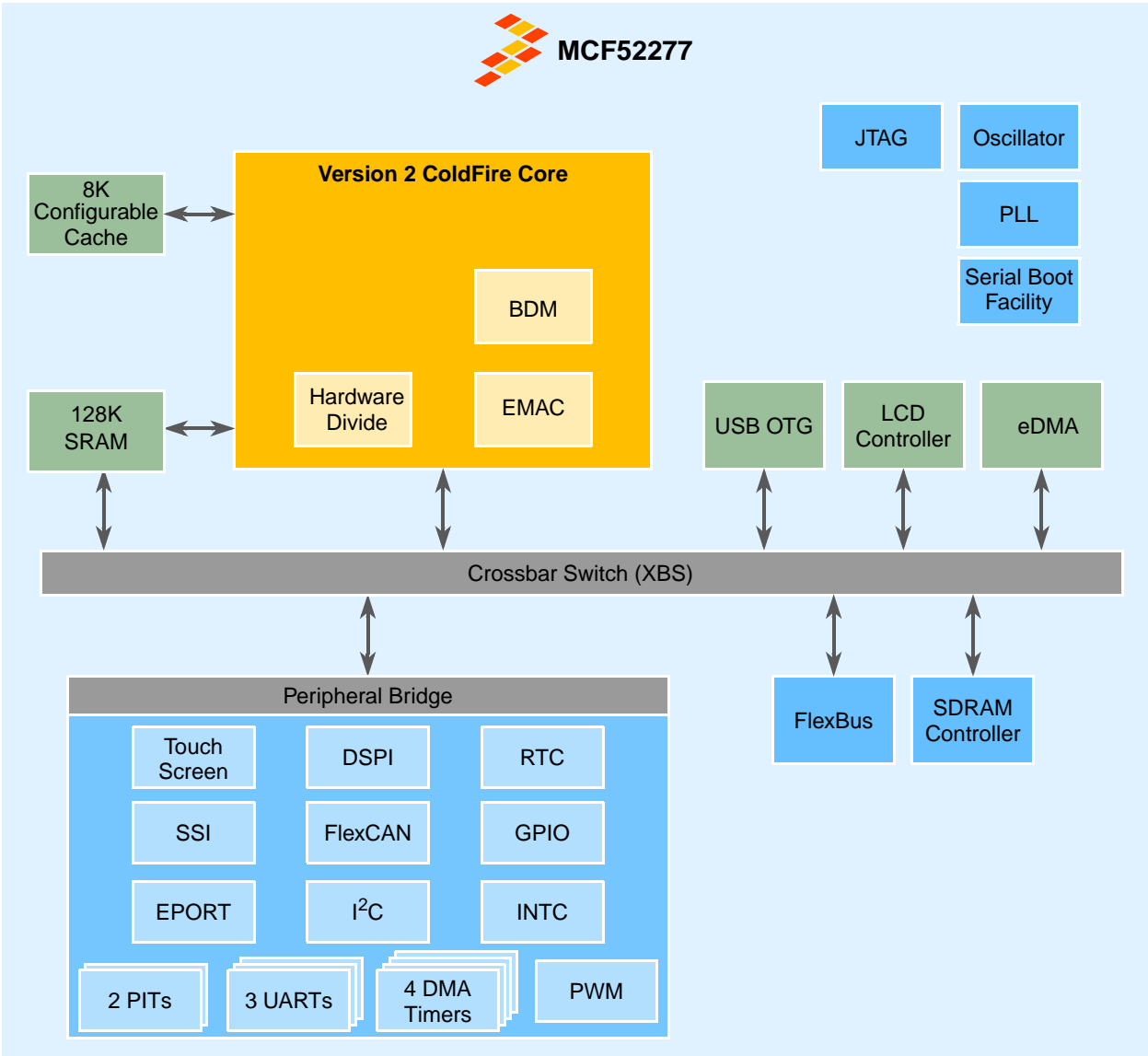
- Version 2 ColdFire® Core with EMAC
- Up to 159 Dhrystone 2.1 MIPS @ 166.67 MHz
- 8 Kbytes configurable cache (instruction only, data only, or split instruction/data)
- 128 Kbytes internal SRAM
- Support for booting from SPI-compatible flash, EEPROM, and FRAM devices
- Crossbar switch technology (XBS) for concurrent access to peripherals or RAM from multiple bus masters
- 16 channel DMA controller
- 16- or 32-bit SDR/DDR controller
- USB 2.0 On-the-Go controller
- Liquid crystal display controller with support up to 800 × 600 pixels
- ADC and touchscreen controller
- FlexCAN module
- 4 32-bit timers with DMA support
- DMA supported serial peripheral interface (DSPI)
- 3 UARTs
- I<sup>2</sup>C bus interface
- Synchronous serial interface (SSI)
- Plus-width modulator (PWM)
- Real-time clock (RTC)
- Two programmable interrupt controllers (PIT)

Freescale reserves the right to change the detail specifications as may be required to permit improvements in the design of its products.

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**LEGEND**

- |                       |                                       |                |   |
|-----------------------|---------------------------------------|----------------|---|
| <b>BDM</b>            | – Background debug module             | <b>LCD</b>     | – Liquid-crystal display                      |
| <b>DSPI</b>           | – DMA serial peripheral interface     | <b>PIT</b>     | – Programmable interrupt timer                |
| <b>eDMA</b>           | – Enhanced direct memory access       | <b>PLL</b>     | – Phase-locked loop module                    |
| <b>EMAC</b>           | – Enhanced multiply-accumulate unit   | <b>PWM</b>     | – Pulse-width modulator                       |
| <b>EPORT</b>          | – Edge port module                    | <b>RTC</b>     | – Real time clock                             |
| <b>GPIO</b>           | – General purpose input/output module | <b>SSI</b>     | – Synchronous serial interface                |
| <b>I<sup>2</sup>C</b> | – Inter-integrated circuit            | <b>UART</b>    | – Universal asynchronous receiver/transmitter |
| <b>INTC</b>           | – Interrupt controller                | <b>USB OTG</b> | – Universal Serial Bus On-the-Go controller   |
| <b>JTAG</b>           | – Joint Test Action Group interface   |                |   |

**Figure 1. MCF52277 Block Diagram**

# 1 MCF5227x Family Comparison

The following table compares the various device derivatives available within the MCF5227x family.

**Table 1. MCF5227x Family Configurations**

| Module  | MCF52274      | MCF52277         |
|---|---------------|------------------|
| ColdFire Version 2 Core with EMAC (Enhanced Multiply-Accumulate Unit) | •             | •                |
| Core (System) Clock   | up to 120 MHz | up to 166.67 MHz |
| Peripheral and External Bus Clock (Core clock ÷ 2)                    | up to 60 MHz  | up to 83.33 MHz  |
| Performance (Dhrystone/2.1 MIPS)                                      | up to 114     | up to 159        |
| Static RAM (SRAM)   | 128 Kbytes    |                  |
| Configurable Cache  | 8 Kbytes      |                  |
| ASP Touchscreen Controller  | •             | •                |
| LCD Controller  | 12-bit color  | 18-bit color     |
| USB 2.0 On-the-Go   | •             | •                |
| FlexBus External Interface  | •             | •                |
| SDR/DDR SDRAM Controller  | •             | •                |
| FlexCAN 2.0B communication module                                     | •             | •                |
| Real Time Clock   | •             | •                |
| Watchdog Timer  | •             | •                |
| 16-channel Direct Memory Access (DMA)                                 | •             | •                |
| Interrupt Controllers (INTC)  | 1             | 1                |
| Synchronous Serial Interface (SSI)                                    | •             | •                |
| I <sup>2</sup> C  | •             | •                |
| DSPI  | •             | •                |
| UARTs   | 3             | 3                |
| 32-bit DMA Timers   | 4             | 4                |
| Periodic Interrupt Timers (PIT)                                       | 2             | 2                |
| PWM Module  | •             | •                |
| Edge Port Module (EPORT)  | •             | •                |
| General Purpose I/O Module (GPIO)                                     | •             | •                |
| JTAG - IEEE <sup>®</sup> 1149.1 Test Access Port                      | •             | •                |
| Package   | 176 LQFP      | 196 MAPBGA       |

## 2 Ordering Information

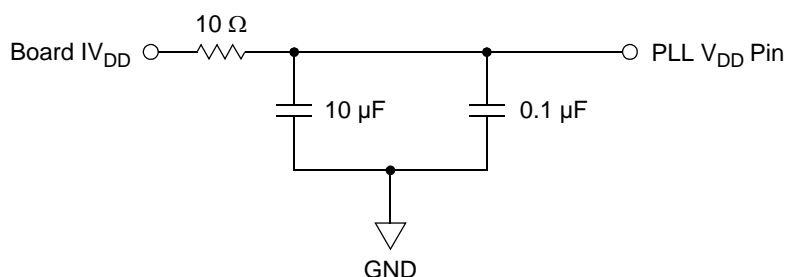
Table 2. Orderable Part Numbers

| Freescall Part Number | Description                  | Package    | Speed      | Temperature    |
|-----------------------|------------------------------|------------|------------|----------------|
| MCF52274CLU120        | MCF52274 RISC Microprocessor | 176 LQFP   | 120 MHz    | -40° to +85° C |
| MCF52277CVM160        | MCF52277 RISC Microprocessor | 196 MAPBGA | 166.67 MHz | -40° to +85° C |

## 3 Hardware Design Considerations

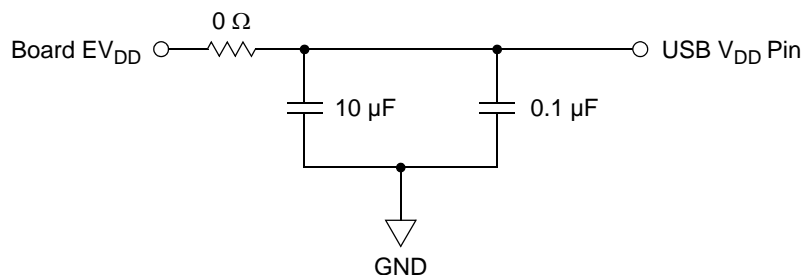
### 3.1 PLL Power Filtering

To further enhance noise isolation, an external filter is strongly recommended for PLL analog  $V_{DD}$  pins. The filter shown in Figure 2 should be connected between the board  $V_{DD}$  and the PLL $V_{DD}$  pins. The resistor and capacitors should be placed as close to the dedicated PLL $V_{DD}$  pin as possible.


 Figure 2. System PLL  $V_{DD}$  Power Filter

### 3.2 USB Power Filtering

To minimize noise, external filters are required for each of the USB power pins. The filter shown in Figure 3 should be connected between the board  $E_{V_{DD}}$  and the USB $V_{DD}$  pin. The resistor and capacitors should be placed as close to the dedicated USB $V_{DD}$  pin as possible.


 Figure 3. USB  $V_{DD}$  Power Filter

#### NOTE

In addition to the above filter circuitry, a 0.01 F capacitor is also recommended in parallel with those shown.

### 3.3 ADC Power Filtering

To minimize noise, an external filter is required for the ADCV<sub>DD</sub> power pin. The filter shown in Figure 4 should be connected between the board EV<sub>DD</sub> and the ADCV<sub>DD</sub> pin. The resistor and capacitors should be placed as close to the dedicated ADCV<sub>DD</sub> pin as possible.

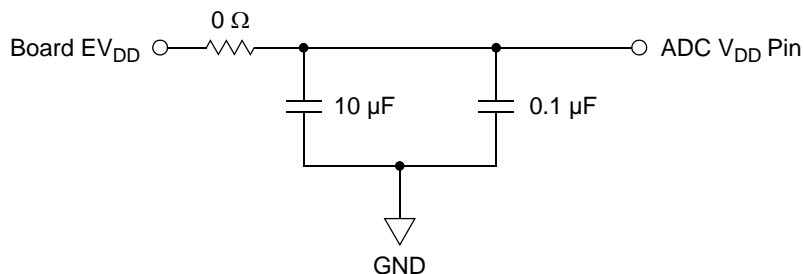


Figure 4. ADC V<sub>DD</sub> Power Filter

### 3.4 Supply Voltage Sequencing

The relationship between SDV<sub>DD</sub> and EV<sub>DD</sub> is non-critical during power-up and power-down sequences. Both SDV<sub>DD</sub> (2.5V or 3.3V) and EV<sub>DD</sub> are specified relative to IV<sub>DD</sub>.

#### 3.4.1 Power Up Sequence

If EV<sub>DD</sub>/SDV<sub>DD</sub> are powered up with IV<sub>DD</sub> at 0 V, then the sense circuits in the I/O pads will cause all pad output drivers connected to the EV<sub>DD</sub>/SDV<sub>DD</sub> to be in a high impedance state. There is no limit on how long after EV<sub>DD</sub>/SDV<sub>DD</sub> powers up before IV<sub>DD</sub> must be powered up. IV<sub>DD</sub> should not lead the EV<sub>DD</sub>, SDV<sub>DD</sub> or PLLV<sub>DD</sub> by more than 0.4 V during power ramp-up, or there will be high current in the internal ESD protection diodes. The rise times on the power supplies should be slower than 500 us to avoid turning on the internal ESD protection clamp diodes.

#### 3.4.2 Power Down Sequence

If IV<sub>DD</sub>/PLLV<sub>DD</sub> are powered down first, then sense circuits in the I/O pads will cause all output drivers to be in a high impedance state. There is no limit on how long after IV<sub>DD</sub> and PLLV<sub>DD</sub> power down before EV<sub>DD</sub> or SDV<sub>DD</sub> must power down. IV<sub>DD</sub> should not lag EV<sub>DD</sub>, SDV<sub>DD</sub>, or PLLV<sub>DD</sub> going low by more than 0.4 V during power down or there will be undesired high current in the ESD protection diodes. There are no requirements for the fall times of the power supplies.

The recommended power down sequence is as follows:

1. Drop IV<sub>DD</sub>/PLLV<sub>DD</sub> to 0 V.
2. Drop EV<sub>DD</sub>/SDV<sub>DD</sub> supplies.

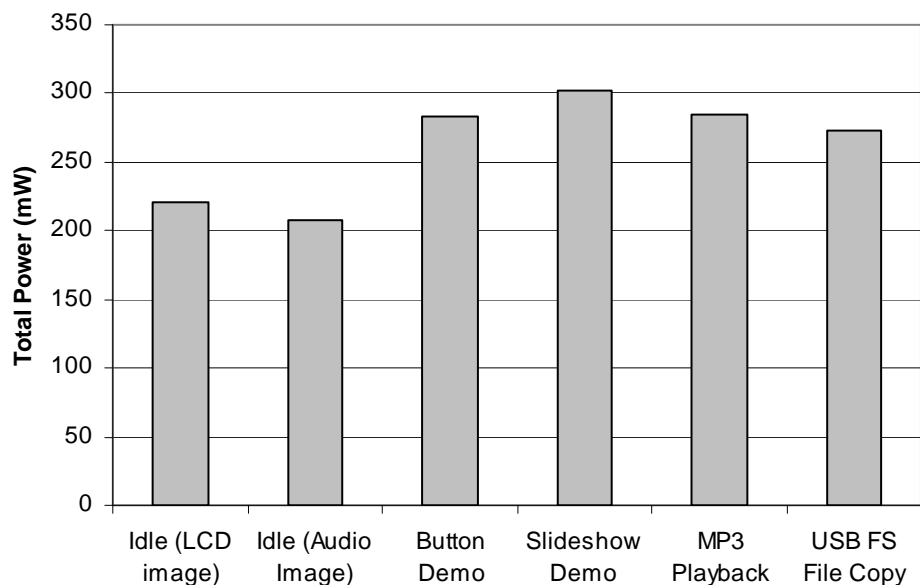
### 3.5 Power Consumption Specifications

All application power consumption data is lab data measured on an M52277EVB running the Freescale Linux BSP.

**Table 3. MCF52277 Application Power Consumption<sup>1</sup>**

| Core Freq. |                    | Idle (LCD image) | Idle (audio image) | Button Demo   | Slideshow Demo | MP3 Playback   | USB FS File Copy | Units     |
|------------|--------------------|------------------|--------------------|---------------|----------------|----------------|------------------|-----------|
| 160 MHz    | $IV_{DD}$          | 61.4             | 59.2               | 84.7          | 96.5           | 89.2           | 89.5             | mA        |
|            | $EV_{DD}$          | 28.87            | 25.73              | 35.3          | 34.6           | 33.46          | 29.86            |           |
|            | $SDV_{DD}$         | 18.8             | 18.57              | 21.8          | 23.9           | 22.66          | 22.2             |           |
|            | <b>Total Power</b> | <b>221.211</b>   | <b>207.135</b>     | <b>282.78</b> | <b>301.95</b>  | <b>285.006</b> | <b>272.748</b>   | <b>mW</b> |

<sup>1</sup> All voltage rails at nominal values:  $IV_{DD} = 1.5\text{ V}$ ,  $EV_{DD} = 3.3\text{ V}$ , and  $SDV_{DD} = 1.8\text{ V}$ .



**Figure 5. Power Consumption in Various Applications**

All current consumption data is lab data measured on a single device using an evaluation board. Table 4 shows the typical power consumption in low-power modes. These current measurements are taken after executing a STOP instruction.

**Table 4. Current Consumption in Low-Power Modes<sup>1,2</sup>**

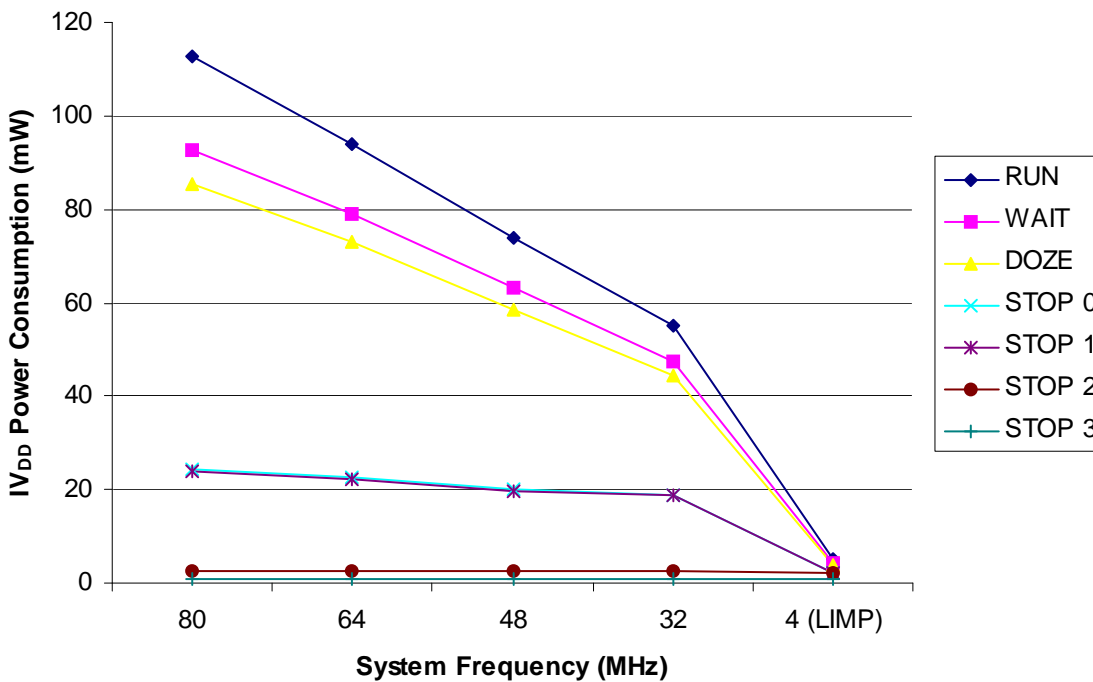
| Mode | Voltage Supply | System Frequency |       |       |       |                  |
|------|----------------|------------------|-------|-------|-------|------------------|
|      |                | 80MHz            | 64MHz | 48MHz | 32MHz | 4MHz (LIMP mode) |
| RUN  | $IV_{DD}$ (mA) | 75.1             | 62.7  | 49.2  | 36.6  | 3.5              |
|      | Power (mW)     | 112.65           | 94.05 | 73.80 | 54.90 | 5.25             |
| WAIT | $IV_{DD}$ (mA) | 61.9             | 52.8  | 42.0  | 31.7  | 2.9              |
|      | Power (mW)     | 92.85            | 79.20 | 63.00 | 47.55 | 4.35             |

**Table 4. Current Consumption in Low-Power Modes<sup>1,2</sup> (continued)**

| Mode   | Voltage Supply | System Frequency |       |       |       |                  |
|--------|----------------|------------------|-------|-------|-------|------------------|
|        |                | 80MHz            | 64MHz | 48MHz | 32MHz | 4MHz (LIMP mode) |
| DOZE   | $I_{DD}$ (mA)  | 57.0             | 48.8  | 38.9  | 29.7  | 2.7              |
|        | Power (mW)     | 85.50            | 73.20 | 58.35 | 44.55 | 4.05             |
| STOP 0 | $I_{DD}$ (mA)  | 16.1             | 15.1  | 13.4  | 12.5  | 1.3              |
|        | Power (mW)     | 24.15            | 22.65 | 20.10 | 18.75 | 1.95             |
| STOP 1 | $I_{DD}$ (mA)  | 15.9             | 14.9  | 13.2  | 12.4  | 1.3              |
|        | Power (mW)     | 23.85            | 22.35 | 19.80 | 18.60 | 1.95             |
| STOP 2 | $I_{DD}$ (mA)  | 1.8              | 1.8   | 1.8   | 1.8   | 1.3              |
|        | Power (mW)     | 2.70             | 2.70  | 2.70  | 2.70  | 1.95             |
| STOP 3 | $I_{DD}$ (mA)  | 0.5              | 0.5   | 0.5   | 0.5   | 0.5              |
|        | Power (mW)     | 0.75             | 0.75  | 0.75  | 0.75  | 0.75             |

<sup>1</sup> All values are measured on an M52277EVB with nominal core voltage ( $I_{DD} = 1.5$  V). Tests performed at room temperature. All peripheral clocks on prior to entering low-power mode

<sup>2</sup> Refer to the Power Management chapter in the *MCF52277 Reference Manual* for more information on low-power modes.



**Figure 6.  $I_{DD}$  Power Consumption in Low-Power Modes**



## 4 Pin Assignments and Reset States

### 4.1 Signal Multiplexing

The following table lists all the MCF5227x pins grouped by function. The direction column is the direction for the primary function of the pin only. Refer to [Section 4, “Pin Assignments and Reset States,”](#) for package diagrams. For a more detailed discussion of the MCF5227x signals, consult the *MCF52277 Reference Manual* (MCF52277RM).

#### NOTE

In this table and throughout this document a single signal within a group is designated without square brackets (i.e., FB\_A23), while designations for multiple signals within a group use brackets (i.e., FB\_A[23:21]) and is meant to include all signals within the two bracketed numbers when these numbers are separated by a colon.

#### NOTE

The primary functionality of a pin is not necessarily its default functionality. Most pins that are muxed with GPIO will default to their GPIO functionality. See [Table 5](#) for a list of the exceptions.

**Table 5. Special-Case Default Signal Functionality**

| Pin            | Default Signal |
|----------------|----------------|
| FB_BE/BWE[3:0] | FB_BE/BWE[3:0] |
| FB_CS[3:0]     | FB_CS[3:0]     |
| FB_OE          | FB_OE          |
| FB_TA          | FB_TA          |
| FB_R/W         | FB_R/W         |
| FB_TS          | FB_TS          |

**Table 6. MCF5227x Signal Information and Muxing**

| Signal Name           | GPIO | Alternate 1 | Alternate 2 | Pull-up (U) <sup>1</sup><br>Pull-down (D) | Direction <sup>2</sup> | Voltage Domain | MCF52274<br>176 LQFP | MCF52277<br>196 MAPBGA |
|-----------------------|------|-------------|-------------|---|------------------------|----------------|----------------------|------------------------|
| <b>Reset</b>          |      |             |             |   |                        |                |                      |                        |
| RESET                 | —    | —           | —           | U   | I                      | EVDD           | 103                  | J11                    |
| RSTOUT                | —    | —           | —           | —   | O                      | EVDD           | 102                  | K11                    |
| <b>Clock</b>          |      |             |             |   |                        |                |                      |                        |
| EXTAL                 | —    | —           | —           | —   | I                      | EVDD           | 106                  | F14                    |
| XTAL                  | —    | —           | —           | U <sup>3</sup>                            | O                      | EVDD           | 105                  | G14                    |
| <b>Mode Selection</b> |      |             |             |   |                        |                |                      |                        |
| BOOTMOD[1:0]          | —    | —           | —           | —   | I                      | EVDD           | 110, 109             | G10, H10               |

Table 6. MCF5227x Signal Information and Muxing (continued)

| Signal Name                                  | GPIO     | Alternate 1                     | Alternate 2 | Pull-up (U) <sup>1</sup><br>Pull-down (D) | Direction <sup>2</sup> | Voltage Domain | MCF52274<br>176 LQFP | MCF52277<br>196 MAPBGA                                 |
|--|----------|---------------------------------|-------------|---|------------------------|----------------|----------------------|--|
| <b>FlexBus</b>                               |          |                                 |             |   |                        |                |                      |  |
| FB_A[23:22]                                  | —        | $\overline{\text{FB\_CS}}[5:4]$ | —           | —   | O                      | SDVDD          | 143, 142             | C11, D11   |
| FB_A[21:16]                                  | —        | —                               | —           | —   | O                      | SDVDD          | 141–139, 137–135     | A12, B12, C12,<br>B13, A13, A14                        |
| FB_A[15:14]                                  | —        | SD_BA[1:0]                      | —           | —   | O                      | SDVDD          | 131, 130             | B14, C13   |
| FB_A[13:11]                                  | —        | SD_A[13:11]                     | —           | —   | O                      | SDVDD          | 129–127              | C14, D12, D13  |
| FB_A10                                       | —        | —                               | —           | —   | O                      | SDVDD          | 126                  | D14  |
| FB_A[9:0]                                    | —        | SD_A[9:0]                       | —           | —   | O                      | SDVDD          | 125–116              | E11–E14,<br>F11–F13, G11,<br>G12, H11                  |
| FB_D[31:16]                                  | —        | SD_D[31:16]                     | —           | —   | I/O                    | SDVDD          | 30–37, 49–56         | J4, K1–K4, L1–L3,<br>M3, N3, P3, M4,<br>N4, P4, L5, M5 |
| FB_D[15:0]                                   | —        | FB_D[31:16]                     | —           | —   | I/O                    | SDVDD          | 19–26, 60–67         | G1–G4, H1–H4,<br>M6, N6, P6, L7,<br>M7, N7, P7, L8     |
| FB_CLK                                       | —        | —                               | —           | —   | O                      | SDVDD          | 42                   | P1   |
| $\overline{\text{FB\_BE/BWE}}[3:0]$          | PBE[3:0] | SD_DQM[3:0]                     | —           | —   | O                      | SDVDD          | 29, 57, 27, 59       | J3, N5, J1, L6   |
| $\overline{\text{FB\_CS}}[3:2]$              | PCS[3:2] | —                               | —           | —   | O                      | SDVDD          | —                    | B11, A11   |
| $\overline{\text{FB\_CS}}1$                  | PCS1     | $\overline{\text{SD\_CS}}1$     | —           | —   | O                      | SDVDD          | 144                  | D10  |
| $\overline{\text{FB\_CS}}0$                  | PCS0     | —                               | —           | —   | O                      | SDVDD          | 145                  | C10  |
| $\overline{\text{FB\_OE}}$                   | PFBCTL3  | —                               | —           | —   | O                      | SDVDD          | 69                   | N8   |
| $\overline{\text{FB\_TA}}$                   | PFBCTL2  | —                               | —           | U   | I                      | SDVDD          | 115                  | H12  |
| $\overline{\text{FB\_R}}\overline{\text{W}}$ | PFBCTL1  | —                               | —           | —   | O                      | SDVDD          | 68                   | M8   |
| $\overline{\text{FB\_TS}}$                   | PFBCTL0  | $\overline{\text{DACK}}0$       | —           | —   | O                      | SDVDD          | 15                   | F4   |
| <b>SDRAM Controller</b>                      |          |                                 |             |   |                        |                |                      |  |
| SD_A10                                       | —        | —                               | —           | —   | O                      | SDVDD          | 46                   | L4   |
| $\overline{\text{SD\_CAS}}$                  | —        | —                               | —           | —   | O                      | SDVDD          | 47                   | N2   |
| SD_CKE                                       | —        | —                               | —           | —   | O                      | SDVDD          | 17                   | F2   |
| SD_CLK                                       | —        | —                               | —           | —   | O                      | SDVDD          | 40                   | M1   |
| $\overline{\text{SD\_CLK}}$                  | —        | —                               | —           | —   | O                      | SDVDD          | 41                   | N1   |
| $\overline{\text{SD\_CS}}0$                  | —        | —                               | —           | —   | O                      | SDVDD          | 18                   | F1   |
| SD_DQS[3:2]                                  | —        | —                               | —           | —   | I/O                    | SDVDD          | 28, 58               | J2, P5   |
| $\overline{\text{SD\_RAS}}$                  | —        | —                               | —           | —   | O                      | SDVDD          | 48                   | P2   |

Table 6. MCF5227x Signal Information and Muxing (continued)

| Signal Name                                 | GPIO        | Alternate 1               | Alternate 2 | Pull-up (U) <sup>1</sup><br>Pull-down (D) | Direction <sup>2</sup> | Voltage Domain | MCF52274<br>176 LQFP | MCF52277<br>196 MAPBGA |
|---|-------------|---------------------------|-------------|---|------------------------|----------------|----------------------|------------------------|
| SD_SDR_DQS                                  | —           | —                         | —           | —   | O                      | SDVDD          | 38                   | M2                     |
| $\overline{\text{SD\_WE}}$                  | —           | —                         | —           | —   | O                      | SDVDD          | 16                   | F3                     |
| <b>External Interrupts Port<sup>4</sup></b> |             |                           |             |   |                        |                |                      |                        |
| $\overline{\text{IRQ7}}$                    | PIRQ7       | —                         | —           | —   | I                      | EVDD           | 162                  | D7                     |
| $\overline{\text{IRQ4}}$                    | PIRQ4       | $\overline{\text{DREQ0}}$ | DSPI_PCS4   | <sup>5</sup>                              | I                      | EVDD           | 161                  | C7                     |
| $\overline{\text{IRQ1}}$                    | PIRQ1       | USB_CLKIN                 | SSI_CLKIN   | —   | I                      | EVDD           | 160                  | B7                     |
| <b>LCD Controller<sup>6</sup></b>           |             |                           |             |   |                        |                |                      |                        |
| LCD_D[17:16] <sup>6</sup>                   | PLCDDH[1:0] | LCD_D[11:10]              | —           | —   | O                      | EVDD           | 9, 8                 | E3, E4                 |
| LCD_D[15:14] <sup>6</sup>                   | PLCDDM[7:6] | LCD_D[9:8]                | —           | —   | O                      | EVDD           | 7, 6                 | D1, D2                 |
| LCD_D13                                     | PLCDDM5     | CANTX                     | —           | —   | O                      | EVDD           | —                    | C1                     |
| LCD_D12                                     | PLCDDM4     | CANRX                     | —           | —   | O                      | EVDD           | —                    | C2                     |
| LCD_D[11:8] <sup>6</sup>                    | PLCDDM[3:0] | LCD_D[7:4]                | —           | —   | O                      | EVDD           | 5–2                  | D3, C3, D4, B1         |
| LCD_D7                                      | PLCDDL7     | PWM7                      | —           | —   | O                      | EVDD           | —                    | B2                     |
| LCD_D6                                      | PLCDDL6     | PWM5                      | —           | —   | O                      | EVDD           | —                    | A1                     |
| LCD_D[5:2] <sup>6</sup>                     | PLCDDL[5:2] | LCD_D[3:0]                | —           | —   | O                      | EVDD           | 175–172              | A2, A3, B3, A4         |
| LCD_D1                                      | PLCDDL1     | PWM3                      | —           | —   | O                      | EVDD           | —                    | B4                     |
| LCD_D0                                      | PLCDDL0     | PWM1                      | —           | —   | O                      | EVDD           | —                    | C4                     |
| LCD_ACD/<br>LCD_OE                          | PLCDCTL3    | LCD_SPL_SPR               | —           | —   | O                      | EVDD           | 169                  | B5                     |
| LCD_FLM/<br>LCD_VSYNC                       | PLCDCTL2    | —                         | —           | —   | O                      | EVDD           | 10                   | E2                     |
| LCD_LP/<br>LCD_HSYNC                        | PLCDCTL1    | —                         | —           | —   | O                      | EVDD           | 11                   | E1                     |
| LCD_LSCLK                                   | PLCDCTL0    | —                         | —           | —   | O                      | EVDD           | 170                  | A5                     |
| <b>USB On-the-Go</b>                        |             |                           |             |   |                        |                |                      |                        |
| USB_DM                                      | —           | —                         | —           | —   | O                      | USB<br>VDD     | 149                  | A9                     |
| USB_DP                                      | —           | —                         | —           | —   | O                      | USB<br>VDD     | 150                  | A10                    |
| <b>Real Time Clock</b>                      |             |                           |             |   |                        |                |                      |                        |
| RTC_EXTAL                                   | —           | —                         | —           | —   | I                      | EVDD           | 100                  | J14                    |
| RTC_XTAL                                    | —           | —                         | —           | —   | O                      | EVDD           | 99                   | K14                    |

Table 6. MCF5227x Signal Information and Muxing (continued)

| Signal Name                              | GPIO    | Alternate 1        | Alternate 2  | Pull-up (U) <sup>1</sup><br>Pull-down (D) | Direction <sup>2</sup> | Voltage Domain | MCF52274<br>176 LQFP | MCF52277<br>196 MAPBGA                       |
|--|---------|--------------------|--------------|---|------------------------|----------------|----------------------|--|
| <b>Touchscreen Controller</b>            |         |                    |              |   |                        |                |                      |  |
| ADC_IN[7:0]                              | —       | —                  | —            | —   | I                      | VDD_<br>ADC    | 82–85, 87–90         | P12, N12, P13,<br>N13, P14, N14,<br>M13, M14 |
| ADC_REF                                  | —       | —                  | —            | —   | I                      | VDD_<br>ADC    | 86                   | M12  |
| <b>I<sup>2</sup>C</b>                    |         |                    |              |   |                        |                |                      |  |
| I2C_SCL                                  | PI2C1   | CANTX              | U2TXD        | U   | I/O                    | EVDD           | 168                  | C5   |
| I2C_SDA                                  | PI2C0   | CANRX              | U2RXD        | U   | I/O                    | EVDD           | 167                  | D5   |
| <b>DSPI<sup>7</sup></b>                  |         |                    |              |   |                        |                |                      |  |
| DSPI_PCS0/ $\overline{SS}$               | PDSP13  | $\overline{U2RTS}$ | —            | U   | I/O                    | EVDD           | 152                  | B9   |
| DSPI_SIN                                 | PDSP12  | U2RXD              | SBF_DI       | <sup>8</sup>                              | I                      | EVDD           | 155                  | D8   |
| DSPI_SOUT                                | PDSP11  | U2TXD              | SBF_D0       | —   | O                      | EVDD           | 154                  | D9   |
| DSPI_SCK                                 | PDSP10  | $\overline{U2CTS}$ | SBF_CK       | —   | I/O                    | EVDD           | 153                  | C9   |
| <b>UARTs</b>                             |         |                    |              |   |                        |                |                      |  |
| $\overline{U1CTS}$                       | PUART7  | SSI_BCLK           | LCD_CLS      | —   | I                      | EVDD           | 156                  | C8   |
| $\overline{U1RTS}$                       | PUART6  | SSI_FS             | LCD_PS       | —   | O                      | EVDD           | 157                  | B8   |
| U1TXD                                    | PUART5  | SSI_TXD            | —            | —   | O                      | EVDD           | 159                  | A7   |
| U1RXD                                    | PUART4  | SSI_RXD            | —            | —   | I                      | EVDD           | 158                  | A8   |
| $\overline{U0CTS}$                       | PUART3  | DT1OUT             | USB_VBUS_EN  | —   | I                      | EVDD           | 97                   | K12  |
| $\overline{U0RTS}$                       | PUART2  | DT1IN              | USB_VBUS_OC  | —   | O                      | EVDD           | 98                   | J12  |
| U0TXD                                    | PUART1  | CANTX              | —            | —   | O                      | EVDD           | 95                   | L12  |
| U0RXD                                    | PUART0  | CANRX              | —            | —   | I                      | EVDD           | 96                   | K13  |
| <b>DMA Timers</b>                        |         |                    |              |   |                        |                |                      |  |
| DT3IN                                    | PTIMER3 | DT3OUT             | SSI_MCLK     | —   | I                      | EVDD           | 163                  | D6   |
| DT2IN/ $\overline{SBF\_CS}$ <sup>7</sup> | PTIMER2 | DT2OUT             | DSPI_PCS2    | —   | I                      | EVDD           | 164                  | C6   |
| DT1IN                                    | PTIMER1 | DT1OUT             | LCD_CONTRAST | —   | I                      | EVDD           | 165                  | B6   |
| DT0IN                                    | PTIMER0 | DT0OUT             | LCD_REV      | —   | I                      | EVDD           | 166                  | A6   |
| <b>BDM/JTAG<sup>9</sup></b>              |         |                    |              |   |                        |                |                      |  |
| PST[3:0]                                 | —       | —                  | —            | —   | O                      | EVDD           | —                    | L9, M9, N9, P9                               |
| DDATA[3:0]                               | —       | —                  | —            | —   | O                      | EVDD           | —                    | L10, M10, N10,<br>P10                        |

Table 6. MCF5227x Signal Information and Muxing (continued)

| Signal Name           | GPIO | Alternate 1       | Alternate 2 | Pull-up (U) <sup>1</sup><br>Pull-down (D) | Direction <sup>2</sup> | Voltage Domain | MCF52274<br>176 LQFP                | MCF52277<br>196 MAPBGA                |
|-----------------------|------|-------------------|-------------|---|------------------------|----------------|-------------------------------------|---------------------------------------|
| ALLPST                | —    | —                 | —           | —   | O                      | EVDD           | 76                                  | —                                     |
| JTAG_EN               | —    | —                 | —           | D   | I                      | EVDD           | 79                                  | K10                                   |
| PSTCLK                | —    | TCLK              | —           | U   | O                      | EVDD           | 74                                  | P8                                    |
| DSI                   | —    | TDI               | —           | U   | I                      | EVDD           | 78                                  | M11                                   |
| DSO                   | —    | TDO               | —           | —   | O                      | EVDD           | 81                                  | L11                                   |
| BKPT <sup>3</sup>     | —    | TMS               | —           | U   | I                      | EVDD           | 80                                  | N11                                   |
| DSCLK                 | —    | TRST <sup>4</sup> | —           | U   | I                      | EVDD           | 77                                  | P11                                   |
| <b>Test</b>           |      |                   |             |   |                        |                |                                     |                                       |
| TEST                  | —    | —                 | —           | D   | I                      | EVDD           | 134                                 | E10                                   |
| <b>Power Supplies</b> |      |                   |             |   |                        |                |                                     |                                       |
| IVDD                  | —    | —                 | —           | —   | —                      | —              | 39, 75, 114, 138,<br>171            | K5, F10, E5, J10                      |
| EVDD                  | —    | —                 | —           | —   | —                      | —              | 12, 72, 73, 94, 111,<br>148, 176    | E6, E7, F5, F6, G5,<br>H9, J9, K8, K9 |
| SD_VDD                | —    | —                 | —           | —   | —                      | —              | 14, 43, 44, 70, 113,<br>132, 146    | E8, E9, F9, G9, H5,<br>J5, J6, K6, K7 |
| VDD_OSC               | —    | —                 | —           | —   | —                      | —              | 108                                 | G13                                   |
| VDD_PLL               | —    | —                 | —           | —   | —                      | —              | 104                                 | H14                                   |
| VDD_USB               | —    | —                 | —           | —   | —                      | —              | 151                                 | B10                                   |
| VDD_RTC               | —    | —                 | —           | —   | —                      | —              | 101                                 | J13                                   |
| VDD_ADC               | —    | —                 | —           | —   | —                      | —              | 91                                  | L13                                   |
| VSS                   | —    | —                 | —           | —   | —                      | —              | 1, 13, 45, 71, 93,<br>112, 133, 147 | F7, F8, G6–G8,<br>H6–H8, J7, J8       |
| VSS_OSC               | —    | —                 | —           | —   | —                      | —              | 107                                 | H13                                   |
| VSS_ADC               | —    | —                 | —           | —   | —                      | —              | 92                                  | L14                                   |

<sup>1</sup> Pull-ups are generally only enabled on pins with their primary function, except as noted.

<sup>2</sup> Refers to pin's primary function.

<sup>3</sup> Enabled only in oscillator bypass mode (internal crystal oscillator is disabled).

<sup>4</sup> GPIO functionality is determined by the edge port module. The GPIO module is only responsible for assigning the alternate functions.

<sup>5</sup> Pull-up when  $\overline{DREQ}$  controls the pin.

<sup>6</sup> The 176 LQFP device only supports a 12-bit LCD data bus.

<sup>7</sup> DSPI or SBF signal functionality is controlled by  $\overline{RESET}$ . When asserted, these pins are configured for serial boot; when negated, the pins are configured for DSPI.

<sup>8</sup> Pull-up when the serial boot facility (SBF) controls the pin.

9 If JTAG\_EN is asserted, these pins default to alternate 1 (JTAG) functionality. The GPIO module is not responsible for assigning these pins.

## 4.2 Pinout—176 LQFP

The pinout for the MCF52274 package is shown below.

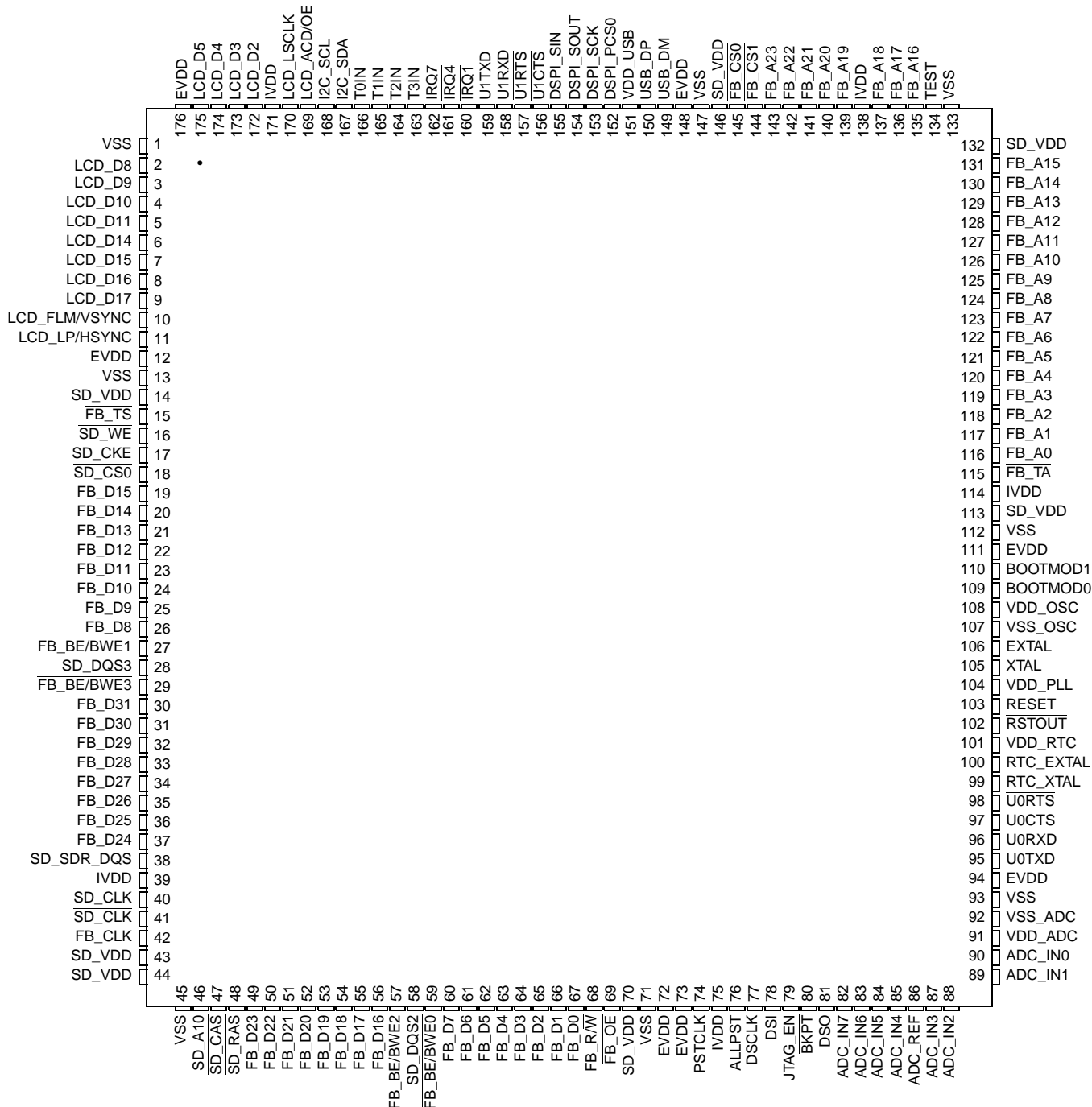


Figure 7. MCF52274 Pinout (176 LQFP)

## 4.3 Pinout—196 MAPBGA

The pinout for the MCF52277 package is shown below.

|   | 1                               | 2                           | 3                               | 4                          | 5                               | 6                               | 7                         | 8                          | 9         | 10                          | 11                          | 12                         | 13      | 14        |   |
|---|---------------------------------|-----------------------------|---------------------------------|----------------------------|---------------------------------|---------------------------------|---------------------------|----------------------------|-----------|-----------------------------|-----------------------------|----------------------------|---------|-----------|---|
| A | LCD_D6                          | LCD_D5                      | LCD_D4                          | LCD_D2                     | LCD_LSCLK                       | T0IN                            | U1TXD                     | U1RXD                      | USB_DM    | USB_DP                      | $\overline{\text{FB\_CS2}}$ | FB_A21                     | FB_A17  | FB_A16    | A |
| B | LCD_D8                          | LCD_D7                      | LCD_D3                          | LCD_D1                     | LCD_ACD/OE                      | T1IN                            | $\overline{\text{IRQ}}_1$ | $\overline{\text{U1RTS}}$  | DSPI_PCS0 | VDD_USB                     | $\overline{\text{FB\_CS3}}$ | FB_A20                     | FB_A18  | FB_A15    | B |
| C | LCD_D13                         | LCD_D12                     | LCD_D10                         | LCD_D0                     | I2C_SCL                         | T2IN                            | $\overline{\text{IRQ}}_4$ | $\overline{\text{U1CTS}}$  | DSPI_SCK  | $\overline{\text{FB\_CS0}}$ | FB_A23                      | FB_A19                     | FB_A14  | FB_A13    | C |
| D | LCD_D15                         | LCD_D14                     | LCD_D11                         | LCD_D9                     | I2C_SDA                         | T3IN                            | $\overline{\text{IRQ}}_7$ | DSPI_SIN                   | DSPI_SOUT | $\overline{\text{FB\_CS1}}$ | FB_A22                      | FB_A12                     | FB_A11  | FB_A10    | D |
| E | LCD_LP/HSYNC                    | LCD_FLM/VSYNC               | LCD_D17                         | LCD_D16                    | IVDD                            | EVDD                            | EVDD                      | SDVDD                      | SDVDD     | TEST                        | FB_A9                       | FB_A8                      | FB_A7   | FB_A6     | E |
| F | $\overline{\text{SD\_CS0}}$     | SD_CKE                      | $\overline{\text{SD\_WE}}$      | $\overline{\text{FB\_TS}}$ | EVDD                            | EVDD                            | VSS                       | VSS                        | SDVDD     | IVDD                        | FB_A5                       | FB_A4                      | FB_A3   | EXTAL     | F |
| G | FB_D15                          | FB_D14                      | FB_D13                          | FB_D12                     | EVDD                            | VSS                             | VSS                       | VSS                        | SDVDD     | BOOT_MOD1                   | FB_A2                       | FB_A1                      | VDD_OSC | XTAL      | G |
| H | FB_D11                          | FB_D10                      | FB_D9                           | FB_D8                      | SDVDD                           | VSS                             | VSS                       | VSS                        | EVDD      | BOOT_MOD0                   | FB_A0                       | $\overline{\text{FB\_TA}}$ | VSS_OSC | VDD_PLL   | H |
| J | $\overline{\text{FB\_BE/BWE1}}$ | SD_DQS3                     | $\overline{\text{FB\_BE/BWE3}}$ | FB_D31                     | SDVDD                           | SDVDD                           | VSS                       | VSS                        | EVDD      | IVDD                        | RESET                       | $\overline{\text{U0RTS}}$  | VDD_RTC | RTC_EXTAL | J |
| K | FB_D30                          | FB_D29                      | FB_D28                          | FB_D27                     | IVDD                            | SDVDD                           | SDVDD                     | EVDD                       | EVDD      | JTAG_EN                     | $\overline{\text{RSTOUT}}$  | $\overline{\text{U0CTS}}$  | U0RXD   | RTC_XTAL  | K |
| L | FB_D26                          | FB_D25                      | FB_D24                          | SD_A10                     | FB_D17                          | $\overline{\text{FB\_BE/BWE0}}$ | FB_D4                     | FB_D0                      | PST3      | DDATA3                      | TDO                         | U0TXD                      | VDD_ADC | VSS_ADC   | L |
| M | SD_CLK                          | SD_SDR_DQS                  | FB_D23                          | FB_D20                     | FB_D16                          | FB_D7                           | FB_D3                     | FB_R $\overline{\text{W}}$ | PST2      | DDATA2                      | TDI                         | ADC_REF                    | ADC_IN1 | ADC_IN0   | M |
| N | $\overline{\text{SD\_CLK}}$     | $\overline{\text{SD\_CAS}}$ | FB_D22                          | FB_D19                     | $\overline{\text{FB\_BE/BWE2}}$ | FB_D6                           | FB_D2                     | $\overline{\text{FB\_OE}}$ | PST1      | DDATA1                      | TMS                         | ADC_IN6                    | ADC_IN4 | ADC_IN2   | N |
| P | FB_CLK                          | $\overline{\text{SD\_RAS}}$ | FB_D21                          | FB_D18                     | SD_DQS0                         | FB_D5                           | FB_D1                     | TCLK                       | PST0      | DDATA0                      | $\overline{\text{TRST}}$    | ADC_IN7                    | ADC_IN5 | ADC_IN3   | P |

Figure 8. MCF52277 Pinout (196 MAPBGA)

## 5 Electrical Characteristics

This document contains electrical specification tables and reference timing diagrams for the MCF5227x microprocessor. This section contains detailed information on DC/AC electrical characteristics and AC timing specifications.

The electrical specifications are preliminary and are from previous designs or design simulations. These specifications may not be fully tested or guaranteed at this early stage of the product life cycle, however for production silicon these specifications will be met. Finalized specifications will be published after complete characterization and device qualifications have been completed.

**NOTE**

The parameters specified in this MCU document supersede any values found in the module specifications.

## 5.1 Maximum Ratings

**Table 7. Absolute Maximum Ratings<sup>1, 2</sup>**

| Characteristic   | Symbol                   | Value        | Unit |
|--|--------------------------|--------------|------|
| Core Supply Voltage  | $IV_{DD}$                | -0.5 to +2.0 | V    |
| CMOS Pad Supply Voltage  | $EV_{DD}$                | -0.3 to +4.0 | V    |
| DDR/Memory Pad Supply Voltage  | $SDV_{DD}$               | -0.3 to +4.0 | V    |
| Oscillator Supply Voltage  | $OSCV_{DD}$              | -0.3 to +4.0 | V    |
| PLL Supply Voltage   | $PLL_{V_{DD}}$           | -0.3 to +2.0 | V    |
| RTC Supply Voltage   | $RTCV_{DD}$              | -0.5 to +2.0 | V    |
| Digital Input Voltage <sup>3</sup>   | $V_{IN}$                 | -0.3 to +3.6 | V    |
| Instantaneous Maximum Current<br>Single pin limit (applies to all pins) <sup>3, 4, 5</sup> | $I_D$                    | 25           | mA   |
| Operating Temperature Range (Packaged)   | $T_A$<br>( $T_L - T_H$ ) | -40 to +85   | °C   |
| Storage Temperature Range  | $T_{stg}$                | -55 to +150  | °C   |

<sup>1</sup> Functional operating conditions are given in [Section 5.4, “DC Electrical Specifications.”](#) Absolute maximum ratings are stress ratings only, and functional operation at the maxima is not guaranteed. Continued operation at these levels may affect device reliability or cause permanent damage to the device.

<sup>2</sup> This device contains circuitry protecting against damage due to high static voltage or electrical fields; however, it is advised that normal precautions be taken to avoid application of any voltages higher than maximum-rated voltages to this high-impedance circuit. Reliability of operation is enhanced if unused inputs are tied to an appropriate logic voltage level (e.g., either  $V_{SS}$  or  $EV_{DD}$ ).

<sup>3</sup> Input must be current limited to the value specified. To determine the value of the required current-limiting resistor, calculate resistance values for positive and negative clamp voltages, then use the larger of the two values.

<sup>4</sup> All functional non-supply pins are internally clamped to  $V_{SS}$  and  $EV_{DD}$ .

<sup>5</sup> Power supply must maintain regulation within operating  $EV_{DD}$  range during instantaneous and operating maximum current conditions. If positive injection current ( $V_{in} > EV_{DD}$ ) is greater than  $I_{DD}$ , the injection current may flow out of  $EV_{DD}$  and could result in external power supply going out of regulation. Insure external  $EV_{DD}$  load will shunt current greater than maximum injection current. This will be the greatest risk when the MCU is not consuming power (ex; no clock). Power supply must maintain regulation within operating  $EV_{DD}$  range during instantaneous and operating maximum current conditions.



## 5.2 Thermal Characteristics

**Table 8. Thermal Characteristics**

| Characteristic                          |                         | Symbol         | 196<br>MAPBGA     | 176<br>LQFP       | Unit |
|---|-------------------------|----------------|-------------------|-------------------|------|
| Junction to ambient, natural convection | Four layer board (2s2p) | $\theta_{JA}$  | 38 <sup>1,2</sup> | 48 <sup>1,2</sup> | °C/W |
| Junction to ambient (@200 ft/min)       | Four layer board (2s2p) | $\theta_{JMA}$ | 34 <sup>1,2</sup> | 42 <sup>1,2</sup> | °C/W |
| Junction to board                       |                         | $\theta_{JB}$  | 27 <sup>3</sup>   | 37 <sup>3</sup>   | °C/W |
| Junction to case                        |                         | $\theta_{JC}$  | 17 <sup>4</sup>   | 14 <sup>4</sup>   | °C/W |
| Junction to top of package              |                         | $\Psi_{jt}$    | 4 <sup>1,5</sup>  | 3 <sup>1,5</sup>  | °C/W |
| Maximum operating junction temperature  |                         | $T_j$          | 105               | 105               | °C   |

<sup>1</sup>  $\theta_{JA}$ ,  $\theta_{JMA}$  and  $\Psi_{jt}$  parameters are simulated in conformance with EIA/JESD Standard 51-2 for natural convection. Freescale recommends the use of  $\theta_{JMA}$  and power dissipation specifications in the system design to prevent device junction temperatures from exceeding the rated specification. System designers should be aware that device junction temperatures can be significantly influenced by board layout and surrounding devices. Conformance to the device junction temperature specification can be verified by physical measurement in the customer's system using the  $\Psi_{jt}$  parameter, the device power dissipation, and the method described in EIA/JESD Standard 51-2.

<sup>2</sup> Per JEDEC JESD51-6 with the board horizontal.

<sup>3</sup> Thermal resistance between the die and the printed circuit board in conformance with JEDEC JESD51-8. Board temperature is measured on the top surface of the board near the package.

<sup>4</sup> Thermal resistance between the die and the case top surface as measured by the cold plate method (MIL SPEC-883 Method 1012.1).

<sup>5</sup> Thermal characterization parameter indicating the temperature difference between package top and the junction temperature per JEDEC JESD51-2. When Greek letters are not available, the thermal characterization parameter is written in conformance with Psi-JT.

The average chip-junction temperature ( $T_j$ ) in °C can be obtained from:

$$T_j = T_A + (P_D \times \theta_{JMA}) \quad \text{Eqn. 1}$$

Where:

|                |  |
|----------------|--|
| $T_A$          | = Ambient Temperature, °C                                      |
| $\theta_{JMA}$ | = Package Thermal Resistance, Junction-to-Ambient, °C/W        |
| $P_D$          | = $P_{INT} + P_{I/O}$  |
| $P_{INT}$      | = $I_{DD} \times IV_{DD}$ , Watts - Chip Internal Power        |
| $P_{I/O}$      | = Power Dissipation on Input and Output Pins - User Determined |

For most applications  $P_{I/O} < P_{INT}$  and can be ignored. An approximate relationship between  $P_D$  and  $T_j$  (if  $P_{I/O}$  is neglected) is:

$$P_D = \frac{K}{(T_j + 273^\circ\text{C})} \quad \text{Eqn. 2}$$

Solving equations 1 and 2 for K gives:

$$K = P_D \times (T_A \times 273^\circ\text{C}) + \theta_{JMA} \times P_D^2 \quad \text{Eqn. 3}$$

where K is a constant pertaining to the particular part. K can be determined from Equation 3 by measuring  $P_D$  (at equilibrium) for a known  $T_A$ . Using this value of K, the values of  $P_D$  and  $T_j$  can be obtained by solving Equation 1 and Equation 2 iteratively for any value of  $T_A$ .

### 5.3 ESD Protection

Table 9. ESD Protection Characteristics<sup>1,2</sup>

| Characteristic                  | Symbol | Value | Unit |
|---------------------------------|--------|-------|------|
| ESD Target for Human Body Model | HBM    | 2000  | V    |

<sup>1</sup> All ESD testing is in conformity with CDF-AEC-Q100 Stress Test Qualification for Automotive Grade Integrated Circuits.

<sup>2</sup> A device is defined as a failure if after exposure to ESD pulses the device no longer meets the device specification requirements. Complete DC parametric and functional testing is performed per applicable device specification at room temperature followed by hot temperature, unless specified otherwise in the device specification.

### 5.4 DC Electrical Specifications

Table 10. DC Electrical Specifications

| Characteristic   | Symbol      | Min  | Max  | Unit |
|--|-------------|--|--|------|
| Core Supply Voltage  | $IV_{DD}$   | 1.4  | 1.6  | V    |
| PLL Supply Voltage   | $PLLV_{DD}$ | 1.4  | 1.6  | V    |
| RTC Supply Voltage   | $RTCV_{DD}$ | 1.4  | 1.6  | V    |
| CMOS Pad Supply Voltage  | $EV_{DD}$   | 3.0  | 3.6  | V    |
| SDRAM and FlexBus Supply Voltage<br>Mobile DDR/Bus Pad Supply Voltage (nominal 1.8V)<br>DDR/Bus Pad Supply Voltage (nominal 2.5V)<br>SDR/Bus Pad Supply Voltage (nominal 3.3V)     | $SDV_{DD}$  | 1.7<br>2.25<br>3.0                                 | 1.95<br>2.75<br>3.6                                      | V    |
| USB Supply Voltage   | $USBV_{DD}$ | 3.0  | 3.6  | V    |
| Oscillator Supply Voltage  | $OSCV_{DD}$ | 3.0  | 3.6  | V    |
| CMOS Input High Voltage  | $EV_{IH}$   | 2  | $EV_{DD} + 0.3$  | V    |
| CMOS Input Low Voltage   | $EV_{IL}$   | $V_{SS} - 0.3$                                     | 0.8  | V    |
| CMOS Output High Voltage<br>$I_{OH} = -5.0$ mA   | $EV_{OH}$   | $EV_{DD} - 0.4$                                    | —  | V    |
| CMOS Output Low Voltage<br>$I_{OL} = 5.0$ mA   | $EV_{OL}$   | —  | 0.4  | V    |
| SDRAM and FlexBus Input High Voltage<br>Mobile DDR/Bus Input High Voltage (nominal 1.8V)<br>DDR/Bus Pad Supply Voltage (nominal 2.5V)<br>SDR/Bus Pad Supply Voltage (nominal 3.3V) | $SDV_{IH}$  | 1.35<br>1.7<br>2                                   | $SDV_{DD} + 0.3$<br>$SDV_{DD} + 0.3$<br>$SDV_{DD} + 0.3$ | V    |
| SDRAM and FlexBus Input Low Voltage<br>Mobile DDR/Bus Input High Voltage (nominal 1.8V)<br>DDR/Bus Pad Supply Voltage (nominal 2.5V)<br>SDR/Bus Pad Supply Voltage (nominal 3.3V)  | $SDV_{IL}$  | $V_{SS} - 0.3$<br>$V_{SS} - 0.3$<br>$V_{SS} - 0.3$ | 0.45<br>0.8<br>0.8                                       | V    |

Table 10. DC Electrical Specifications (continued)

| Characteristic  | Symbol     | Min               | Max               | Unit    |
|---|------------|-------------------|-------------------|---------|
| SDRAM and FlexBus Output High Voltage<br>Mobile DDR/Bus Input High Voltage (nominal 1.8V)<br>DDR/Bus Pad Supply Voltage (nominal 2.5V)<br>SDR/Bus Pad Supply Voltage (nominal 3.3V)<br>$I_{OH} = -5.0$ mA for all modes | $SDV_{OH}$ | 1.4<br>2.1<br>2.4 | —<br>—<br>—       | V       |
| SDRAM and FlexBus Output Low Voltage<br>Mobile DDR/Bus Input High Voltage (nominal 1.8V)<br>DDR/Bus Pad Supply Voltage (nominal 2.5V)<br>SDR/Bus Pad Supply Voltage (nominal 3.3V)<br>$I_{OL} = 5.0$ mA for all modes   | $SDV_{OL}$ | —<br>—<br>—       | 0.3<br>0.3<br>0.5 | V       |
| Input Leakage Current<br>$V_{in} = V_{DD}$ or $V_{SS}$ , Input-only pins  | $I_{in}$   | -1.0              | 1.0               | $\mu$ A |
| Weak Internal Pull-Up Device Current, tested at $V_{IL}$ Max. <sup>1</sup>  | $I_{APU}$  | -10               | -130              | $\mu$ A |
| Input Capacitance <sup>2</sup><br>All input-only pins<br>All input/output (three-state) pins  | $C_{in}$   | —<br>—            | 7<br>7            | pF      |

<sup>1</sup> Refer to the signals section for pins having weak internal pull-up devices.

<sup>2</sup> This parameter is characterized before qualification rather than 100% tested.

## 5.5 Oscillator and PLL Electrical Characteristics

Table 11. PLL Electrical Characteristics

| Num | Characteristic                           | Symbol             | Min                 | Max                | Unit  |
|-----|--|--------------------|---------------------|--------------------|-------|
| 1   | PLL Reference Frequency Range            |                    |                     |                    |       |
|     | Crystal reference                        | $f_{ref\_crystal}$ | 16                  | 25 <sup>1</sup>    | MHz   |
|     | External reference                       | $f_{ref\_ext}$     | 16                  | 66.67 <sup>1</sup> | MHz   |
| 2   | Core/system frequency                    | $f_{sys}$          | 512 Hz <sup>2</sup> | 166.67             | MHz   |
|     | CLKOUT Frequency                         | $f_{sys/2}$        | 256 Hz <sup>2</sup> | 83.33              | MHz   |
| 3   | Crystal Start-up Time <sup>3,4</sup>     | $t_{cst}$          | —                   | 10                 | ms    |
| 4   | EXTAL Input High Voltage                 |                    |                     |                    |       |
|     | Crystal Mode <sup>5</sup>                | $V_{IHEXT}$        | $V_{XTAL} + 0.4$    | —                  | V     |
|     | All other modes (External, Limp)         | $V_{IHEXT}$        | $E_{VDD}/2 + 0.4$   | —                  | V     |
| 5   | EXTAL Input Low Voltage                  |                    |                     |                    |       |
|     | Crystal Mode <sup>5</sup>                | $V_{ILEXT}$        | —                   | $V_{XTAL} - 0.4$   | V     |
|     | All other modes (External, Limp)         | $V_{ILEXT}$        | —                   | $E_{VDD}/2 - 0.4$  | V     |
| 7   | PLL Lock Time <sup>3,6</sup>             | $t_{pll}$          | —                   | 50000              | CLKIN |
| 8   | Duty cycle of reference <sup>3</sup>     | $t_{dc}$           | 40                  | 60                 | %     |
| 9   | XTAL Current                             | $I_{XTAL}$         | 1                   | 3                  | mA    |
| 10  | Total on-chip stray capacitance on XTAL  | $C_{S\_XTAL}$      | —                   | 1.5                | pF    |
| 11  | Total on-chip stray capacitance on EXTAL | $C_{S\_EXTAL}$     | —                   | 1.5                | pF    |
| 12  | Crystal capacitive load                  | $C_L$              | See crystal spec    |                    |       |

**Table 11. PLL Electrical Characteristics (continued)**

| Num | Characteristic  | Symbol                          | Min    | Max  | Unit                           |
|-----|---|---------------------------------|--------|--|--------------------------------|
| 13  | Discrete load capacitance for XTAL<br>Discrete load capacitance for EXTAL   | $C_{L\_XTAL}$<br>$C_{L\_EXTAL}$ | —      | $2 \times (C_L - C_{S\_XTAL} - C_{S\_EXTAL} - C_{S\_PCB})^7$ | pF                             |
| 14  | Frequency un-LOCK Range   | $f_{UL}$                        | -4.0   | 4.0  | % $f_{sys}$                    |
| 15  | Frequency LOCK Range  | $f_{LCK}$                       | -2.0   | 2.0  | % $f_{sys}$                    |
| 17  | CLKOUT period jitter <sup>4, 5, 8</sup> measured at $f_{sys}$ max<br>Peak-to-peak jitter (Clock edge to clock edge)<br>Long-term jitter | $C_{jitter}$                    | —<br>— | 10<br>TBD  | % $f_{sys/2}$<br>% $f_{sys/2}$ |
| 19  | VCO frequency ( $f_{vco} = f_{ref} \times PFDR$ )   | $f_{vco}$                       | 350    | 540  | MHz                            |

<sup>1</sup> Although these are the allowable frequency ranges, do not violate the VCO frequency range of the PLL. See the *MCF5227x Reference Manual* for more details.

<sup>2</sup> The minimum system frequency is the minimum input clock divided by the maximum low-power divider (16 MHz ÷ 32,768). When the PLL is enabled, the minimum system frequency ( $f_{sys}$ ) is 37.5 MHz.

<sup>3</sup> This parameter is guaranteed by characterization before qualification rather than 100% tested. Applies to external clock reference only.

<sup>4</sup> Proper PC board layout procedures must be followed to achieve specifications.

<sup>5</sup> This parameter is guaranteed by design rather than 100% tested.

<sup>6</sup> This specification is the PLL lock time only and does not include oscillator start-up time..

<sup>7</sup>  $C_{S\_PCB}$  is the measured PCB stray capacitance on EXTAL and XTAL.

<sup>8</sup> Jitter is the average deviation from the programmed frequency measured over the specified interval at maximum  $f_{sys}$ . Measurements are made with the device powered by filtered supplies and clocked by a stable external clock signal. Noise injected into the PLL circuitry via PLL  $V_{DD}$ ,  $EV_{DD}$ , and  $V_{SS}$  and variation in crystal oscillator frequency increase the  $C_{jitter}$  percentage for a given interval.

## 5.6 ASP Electrical Characteristics

Table 12 lists the electrical specifications for the ASP module.

**Table 12. ASP Electrical Characteristics**

| Characteristic                 | Symbol         | Min | Typical | Max       | Unit             |
|--------------------------------|----------------|-----|---------|-----------|------------------|
| ASP Analog Supply Voltage      | $V_{DDA}$      | 3.0 | —       | 3.6       | V                |
| Input Voltage Range            | $V_{ADIN}$     | 0   | —       | $V_{DDA}$ | V                |
| Operating Current Consumption  | $I_{DDA\_ON}$  | —   | 700     | —         | uA               |
| Power-down Current Consumption | $I_{DDA\_OFF}$ | —   | 1       | —         | uA               |
| Resolution                     | $R_{ES}$       | —   | —       | 12        | bits             |
| Sampling rate                  |                | —   | —       | 125       | kS/s             |
| Integral Non-linearity         | INL            | —   | ±8      | ±24       | lsb <sup>1</sup> |
| Differential Non-linearity     | DNL            | —   | ±2      | ±24       | lsb <sup>1</sup> |
| ADC Internal Clock Frequency   | $t_{AIC}$      | 2   | —       | 8         | MHz              |
| Conversion Range               | $R_{AD}$       | 0   | —       | $V_{DDA}$ | V                |

**Table 12. ASP Electrical Characteristics (continued)**

| Characteristic            | Symbol    | Min | Typical   | Max       | Unit             |
|---------------------------|-----------|-----|-----------|-----------|------------------|
| Conversion Time           | $t_{ADC}$ | 15  | —         | 32        | $t_{AIC}$ cycles |
| Sample Time               | $t_{ADS}$ | 3   | —         | 20        | $t_{AIC}$ cycles |
| Multiplexer Settling Time | $t_{AMS}$ | —   | —         | 3         | $t_{AIC}$ cycles |
| Zero-scale Error          | ZE        | —   | $\pm 4$   | $\pm 12$  | lsb <sup>1</sup> |
| Full-scale Error          | FE        | —   | $\pm 320$ | $\pm 370$ | lsb <sup>1</sup> |
| Input Capacitance         | $C_{AIN}$ | —   | —         | 34        | pF               |

<sup>1</sup> A least significant bit (lsb) is a unit of voltage equal to the smallest resolution of the ADC. This unit of measure approximately relates the error voltage to the observed error in conversion (code error), and is useful for systemic errors such as differential non-linearity. A 2.56-V input on an ADC with  $\pm 3$  lsb of error could read between 0x1FD and 0x203. This unit is by far the most common terminology and will be the preferred unit used for error representation.

A bit is a unit equal to the log (base2) of the error voltage normalized to the resolution of the ADC. An error of N bits corresponds to  $2^N$  lsb of error. This measure is easily confused with lsb and is hard to extrapolate between integer values.

## 5.7 External Interface Timing Specifications

### 5.7.1 FlexBus

A multi-function external bus interface called FlexBus is provided with basic functionality to interface to slave-only devices up to a maximum bus frequency of 66MHz. It can be directly connected to asynchronous or synchronous devices such as external boot ROMs, flash memories, gate-array logic, or other simple target (slave) devices with little or no additional circuitry. For asynchronous devices a simple chip-select based interface can be used.

All processor bus timings are synchronous; that is, input setup/hold and output delay are given in respect to the rising edge of a reference clock, FB\_CLK. The FB\_CLK frequency may be the same as the internal system bus frequency or an integer divider of that frequency.

The following timing numbers indicate when data will be latched or driven onto the external bus, relative to the Flexbus output clock, FB\_CLK. All other timing relationships can be derived from these values.

**Table 13. FlexBus AC Timing Specifications**

| Num | Characteristic  | Symbol        | Min  | Max   | Unit | Notes           |
|-----|---|---------------|------|-------|------|-----------------|
|     | Frequency of Operation  |               | —    | 83.33 | MHz  | $f_{sys}/2$     |
| FB1 | Clock Period (FB_CLK)   | $t_{FBCK}$    | 12.0 | —     | ns   | $t_{cyc}$       |
| FB2 | Address, Data, and Control Output Valid (FB_A[23:0], FB_D[31:0], FB_CS[5:0], FB_R/W, FB_TS, FB_BE/BWE[3:0] and FB_OE) | $t_{FBCHDCV}$ | —    | 7.0   | ns   | <sup>1</sup>    |
| FB3 | Address, Data, and Control Output Hold (FB_A[23:0], FB_D[31:0], FB_CS[5:0], FB_R/W, FB_TS, FB_BE/BWE[3:0], and FB_OE) | $t_{FBCHDCI}$ | 1    | —     | ns   | <sup>1, 2</sup> |

**Table 13. FlexBus AC Timing Specifications (continued)**

| Num | Characteristic                                       | Symbol       | Min | Max | Unit | Notes |
|-----|--|--------------|-----|-----|------|-------|
| FB4 | Data Input Setup                                     | $t_{DVFBCH}$ | 3.5 | —   | ns   |       |
| FB5 | Data Input Hold                                      | $t_{DIFBCH}$ | 0   | —   | ns   |       |
| FB6 | Transfer Acknowledge ( $\overline{TA}$ ) Input Setup | $t_{CVFBCH}$ | 4   | —   | ns   |       |
| FB7 | Transfer Acknowledge ( $\overline{TA}$ ) Input Hold  | $t_{CIFBCH}$ | 0   | —   | ns   |       |

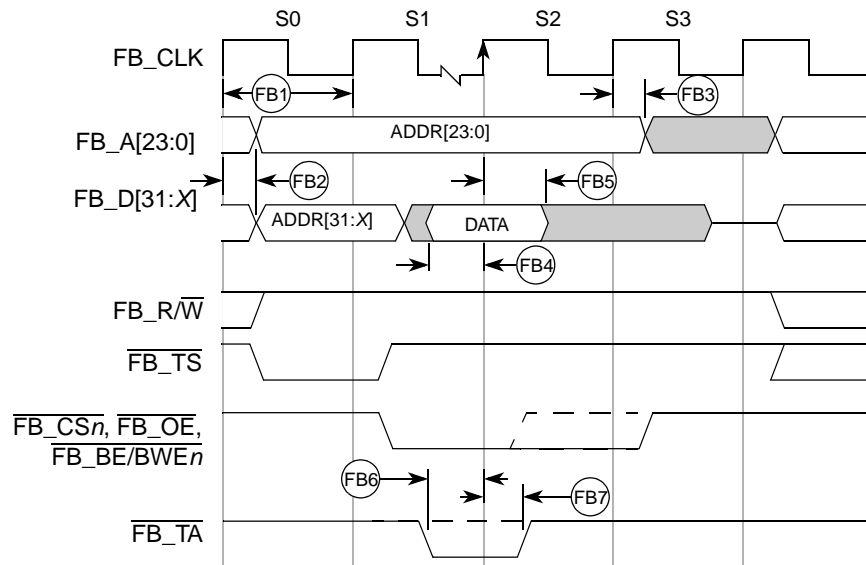
<sup>1</sup> Timing for chip selects only applies to the  $\overline{FB\_CS}[5:0]$  signals. Please see [Section 5.7.2.2, "DDR SDRAM AC Timing Specifications,"](#) for  $\overline{SD\_CS}[3:0]$  timing.

<sup>2</sup> The FlexBus supports programming an extension of the address hold. Please consult the device reference manual for more information.

**NOTE**

The processor drives the data lines during the first clock cycle of the transfer with the full 32-bit address. This may be ignored by standard connected devices using non-multiplexed address and data buses. However, some applications may find this feature beneficial.

The address and data busses are muxed between the FlexBus and SDRAM controller. At the end of the read and write bus cycles the address signals are indeterminate.



**Figure 9. FlexBus Read Timing**

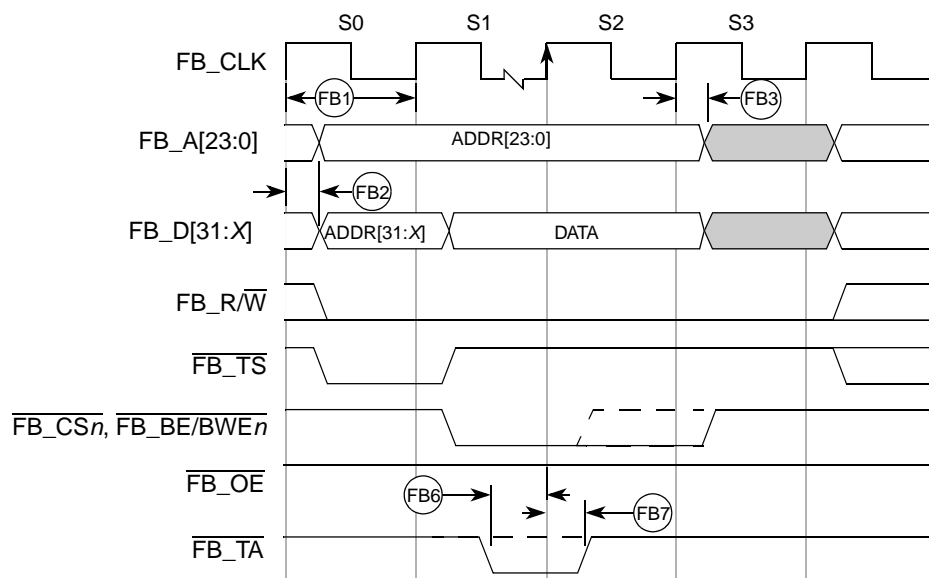


Figure 10. Flexbus Write Timing

## 5.7.2 SDRAM Bus

The SDRAM controller supports accesses to main SDRAM memory from any internal master. It supports either standard SDRAM or double data rate (DDR) SDRAM, but it does not support both at the same time.

### 5.7.2.1 SDR SDRAM AC Timing Specifications

The following timing numbers indicate when data will be latched or driven onto the external bus, relative to the memory bus clock, when operating in SDR mode on write cycles and relative to SD\_DQS on read cycles. The device's SDRAM controller is a DDR controller that has an SDR mode. Because it is designed to support DDR, a DQS pulse must still be supplied to the device for each data beat of an SDR read. The processor accomplishes this by asserting a signal named SD\_SDR\_DQS during read cycles. Care must be taken during board design to adhere to the following guidelines and specs with regard to the SD\_SDR\_DQS signal and its usage.

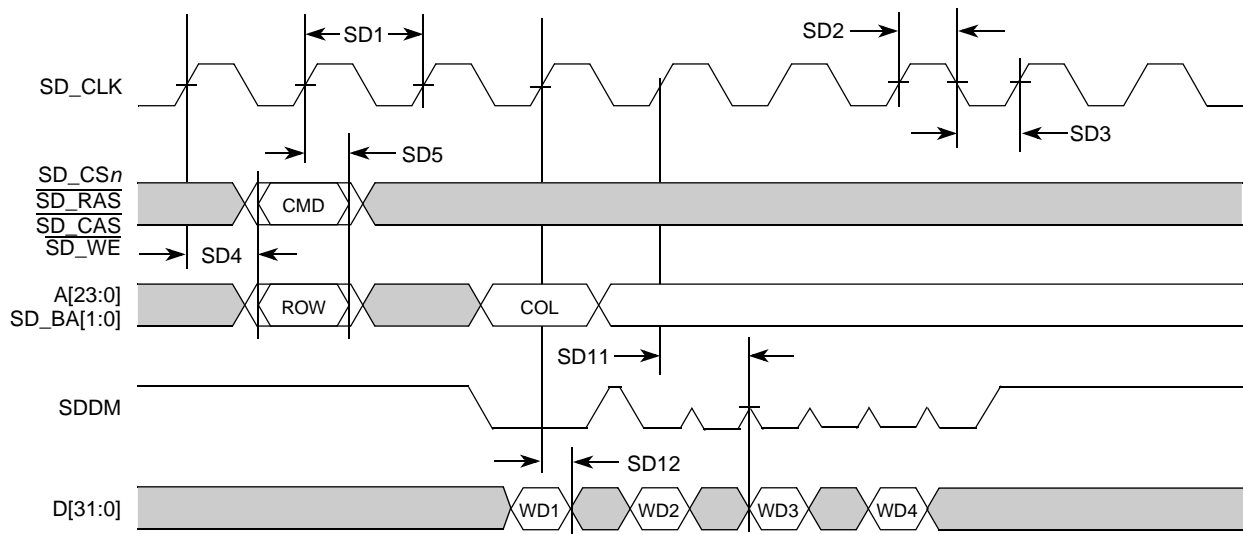
Table 14. SDR Timing Specifications

| Num | Characteristic   | Symbol        | Min                   | Max                        | Unit   | Notes        |
|-----|--|---------------|-----------------------|----------------------------|--------|--------------|
|     | Frequency of Operation   |               | 60                    | 83.33                      | MHz    | <sup>1</sup> |
| SD1 | Clock Period   | $t_{SDCK}$    | 12.0                  | 16.67                      | ns     | <sup>2</sup> |
| SD2 | Pulse Width High   | $t_{SDCKH}$   | 0.45                  | 0.55                       | SD_CLK | <sup>3</sup> |
| SD3 | Pulse Width Low  | $t_{SDCKL}$   | 0.45                  | 0.55                       | SD_CLK | <sup>3</sup> |
| SD4 | Address, $\overline{SD\_CKE}$ , $\overline{SD\_CAS}$ , $\overline{SD\_RAS}$ , $\overline{SD\_WE}$ , SD_BA, SD_CS[1:0] - Output Valid | $t_{SDCHACV}$ | —                     | $0.5 \times SD\_CLK + 1.0$ | ns     |              |
| SD5 | Address, $\overline{SD\_CKE}$ , $\overline{SD\_CAS}$ , $\overline{SD\_RAS}$ , $\overline{SD\_WE}$ , SD_BA, SD_CS[1:0] - Output Hold  | $t_{SDCHACI}$ | 2.0                   | —                          | ns     |              |
| SD6 | SD_SDR_DQS Output Valid  | $t_{DQSOV}$   | —                     | Self timed                 | ns     | <sup>4</sup> |
| SD7 | SD_DQS[3:2] input setup relative to SD_CLK   | $t_{DQVSDCH}$ | $0.25 \times SD\_CLK$ | $0.40 \times SD\_CLK$      | ns     | <sup>5</sup> |

**Table 14. SDR Timing Specifications (continued)**

| Num  | Characteristic   | Symbol        | Min   | Max                      | Unit | Notes        |
|------|--|---------------|---|--------------------------|------|--------------|
| SD8  | SD_DQS[3:2] input hold relative to SD_CLK                      | $t_{DQISDCH}$ | Does not apply. $0.5 \times SD\_CLK$ fixed width. |                          |      | <sup>6</sup> |
| SD9  | Data (D[31:0]) Input Setup relative to SD_CLK (reference only) | $t_{DVSDCH}$  | $0.25 \times SD\_CLK$                             | —                        | ns   | <sup>7</sup> |
| SD10 | Data Input Hold relative to SD_CLK (reference only)            | $t_{DISDCH}$  | 1.0   | —                        | ns   |              |
| SD11 | Data (D[31:0]) and Data Mask (SD_DQM[3:0]) Output Valid        | $t_{SDCHDMV}$ | —   | $0.5 \times SD\_CLK + 2$ | ns   |              |
| SD12 | Data (D[31:0]) and Data Mask (SD_DQM[3:0]) Output Hold         | $t_{SDCHDMI}$ | 1.5   | —                        | ns   |              |

- <sup>1</sup> The device supports same frequency of operation for both FlexBus and SDRAM clock operates as that of the internal bus clock. Please see the PLL chapter of the device reference manual for more information on setting the SDRAM clock rate.
- <sup>2</sup> SD\_CLK is one SDRAM clock in ns.
- <sup>3</sup> Pulse width high plus pulse width low cannot exceed min and max clock period.
- <sup>4</sup> SD\_SDR\_DQS is designed to pulse 0.25 clock before the rising edge of the memory clock. This is a guideline only. Subtle variation from this guideline is expected. SD\_SDR\_DQS will only pulse during a read cycle and one pulse will occur for each data beat.
- <sup>5</sup> SD\_DQS is designed to pulse 0.25 clock before the rising edge of the memory clock. This spec is a guideline only. Subtle variation from this guideline is expected. SD\_DQS will only pulse during a read cycle and one pulse will occur for each data beat.
- <sup>6</sup> The SD\_DQS pulse is designed to be 0.5 clock in width. The timing of the rising edge is most important. The falling edge does not affect the memory controller.
- <sup>7</sup> Since a read cycle in SDR mode still uses the DQS circuit within the device, it is critical that the data valid window be centered 1/4 clk after the rising edge of DQS. Ensuring that this happens will result in successful SDR reads. The input setup spec is provided as guidance.



**Figure 11. SDR Write Timing**



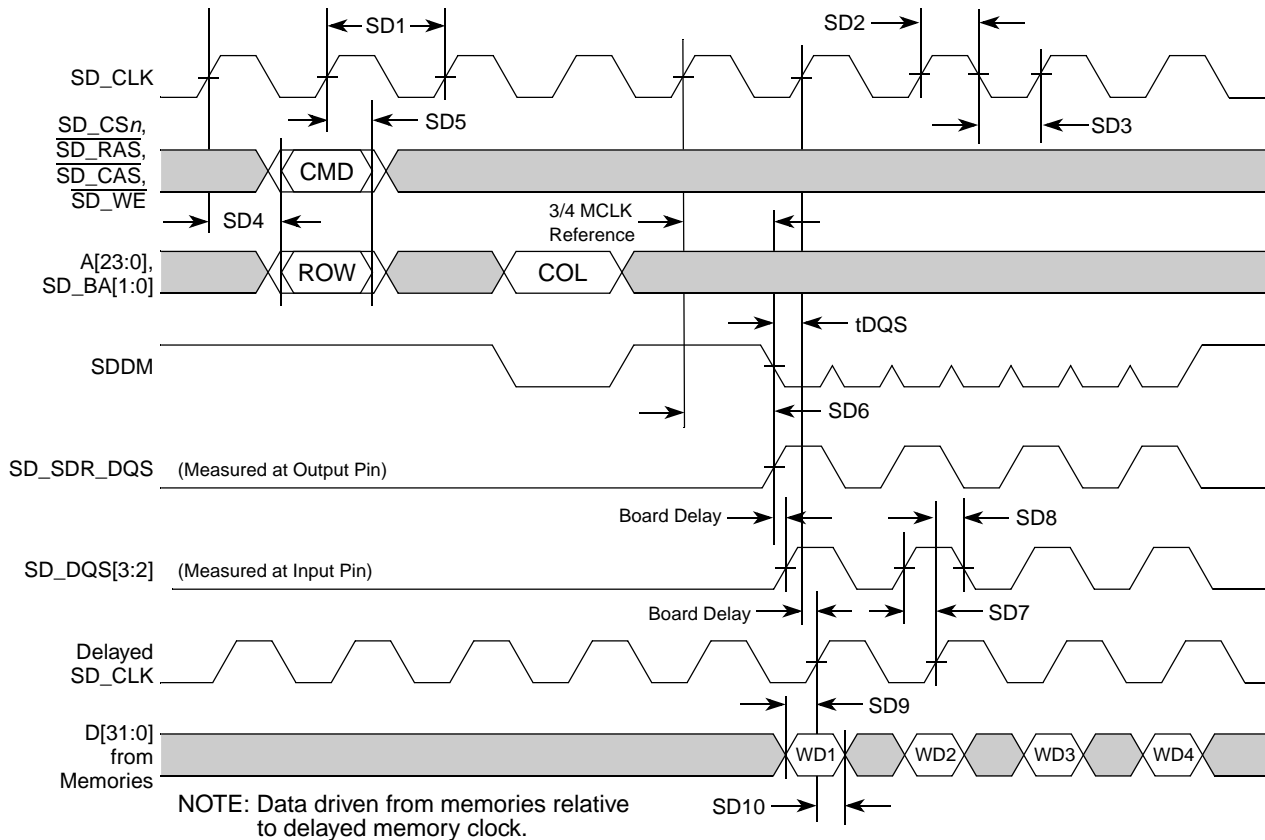


Figure 12. SDR Read Timing

### 5.7.2.2 DDR SDRAM AC Timing Specifications

When using the SDRAM controller in DDR mode, the following timing numbers must be followed to properly latch or drive data onto the memory bus. All timing numbers are relative to the two DQS byte lanes.

Table 15. DDR Timing Specifications

| Num | Characteristic  | Symbol        | Min  | Max                        | Unit   | Notes  |
|-----|---|---------------|------|----------------------------|--------|--------|
|     | Frequency of Operation  | $t_{DDCK}$    | 60   | 83.33                      | MHz    | 1      |
| DD1 | Clock Period  | $t_{DDSK}$    | 12.0 | 16.67                      | ns     | 2      |
| DD2 | Pulse Width High  | $t_{DDCKH}$   | 0.45 | 0.55                       | SD_CLK | 3      |
| DD3 | Pulse Width Low   | $t_{DDCKL}$   | 0.45 | 0.55                       | SD_CLK | 3      |
| DD4 | Address, $\overline{SD\_CKE}$ , $\overline{SD\_CAS}$ , $\overline{SD\_RAS}$ , $\overline{SD\_WE}$ , $\overline{SD\_CS}[1:0]$ - Output Valid | $t_{SDCHACV}$ | —    | $0.5 \times SD\_CLK + 1.0$ | ns     | 4      |
| DD5 | Address, $\overline{SD\_CKE}$ , $\overline{SD\_CAS}$ , $\overline{SD\_RAS}$ , $\overline{SD\_WE}$ , $\overline{SD\_CS}[1:0]$ - Output Hold  | $t_{SDCHACI}$ | 2.0  | —                          | ns     |        |
| DD6 | Write Command to first DQS Latching Transition  | $t_{CMDVDQ}$  | —    | 1.25                       | SD_CLK |        |
| DD7 | Data and Data Mask Output Setup (DQ→DQS) Relative to DQS (DDR Write Mode)   | $t_{DQDMV}$   | 1.5  | —                          | ns     | 5<br>6 |

**Table 15. DDR Timing Specifications (continued)**

| Num  | Characteristic   | Symbol        | Min                                | Max | Unit | Notes |
|------|--|---------------|------------------------------------|-----|------|-------|
| DD8  | Data and Data Mask Output Hold (DQS→DQ) Relative to DQS (DDR Write Mode) | $t_{DQDMI}$   | 1.0                                | —   | ns   | 7     |
| DD9  | Input Data Skew Relative to DQS (Input Setup)                            | $t_{DVDQ}$    | —                                  | 1   | ns   | 8     |
| DD10 | Input Data Hold Relative to DQS  | $t_{DIDQ}$    | $0.25 \times SD\_CLK$<br>$+ 0.5ns$ | —   | ns   | 9     |
| DD11 | DQS falling edge from SDCLK rising (output hold time)                    | $t_{DQLSDCH}$ | 0.5                                | —   | ns   |       |

- <sup>1</sup> The frequency of operation is either 2x or 4x the FB\_CLK frequency of operation. FlexBus and SDRAM clock operate at the same frequency as the internal bus clock.
- <sup>2</sup> SD\_CLK is one SDRAM clock in ns.
- <sup>3</sup> Pulse-width high plus pulse-width low cannot exceed minimum or maximum clock period.
- <sup>4</sup> Command output valid should be one-half the memory bus clock (SD\_CLK) plus some minor adjustments for process, temperature, and voltage variations.
- <sup>5</sup> This specification relates to the required input setup time of today's DDR memories. The device's output setup should be larger than the input setup of the DDR memories. If it is not larger, then the input setup on the memory will be in violation. MEM\_DATA[31:24] is relative to MEM\_DQS[3], MEM\_DATA[23:16] is relative to MEM\_DQS[2], MEM\_DATA[15:8] is relative to MEM\_DQS[1], and MEM\_DATA[7:0] is relative MEM\_DQS[0].
- <sup>6</sup> The first data beat will be valid before the first rising edge of DQS and after the DQS write preamble. The remaining data beats will be valid for each subsequent DQS edge.
- <sup>7</sup> This specification relates to the required hold time of today's DDR memories. MEM\_DATA[31:24] is relative to MEM\_DQS[3], MEM\_DATA[23:16] is relative to MEM\_DQS[2], MEM\_DATA[15:8] is relative to MEM\_DQS[1], and MEM\_DATA[7:0] is relative MEM\_DQS[0].
- <sup>8</sup> Data input skew is derived from each DQS clock edge. It begins with a DQS transition and ends when the last data line becomes valid. This input skew must include DDR memory output skew and system-level board skew (due to routing or other factors).
- <sup>9</sup> Data input hold is derived from each DQS clock edge. It begins with a DQS transition and ends when the first data line becomes invalid.

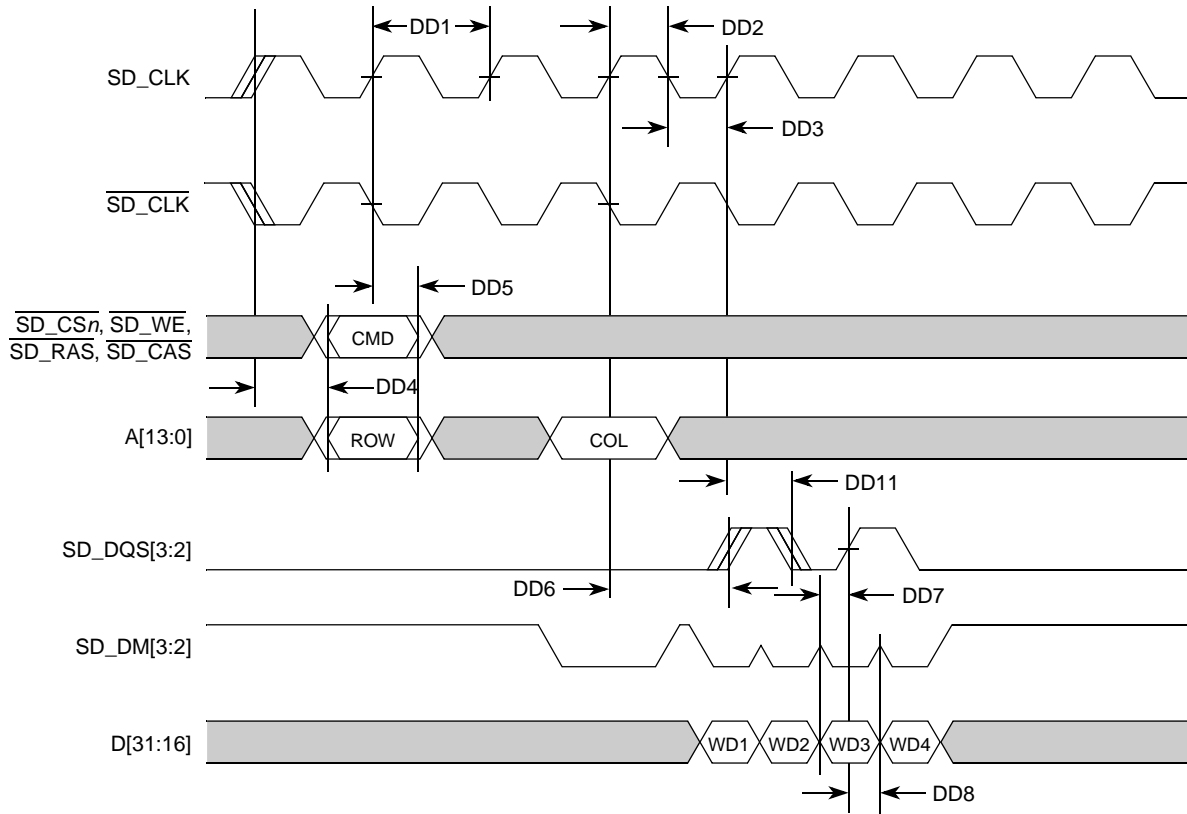


Figure 13. DDR Write Timing

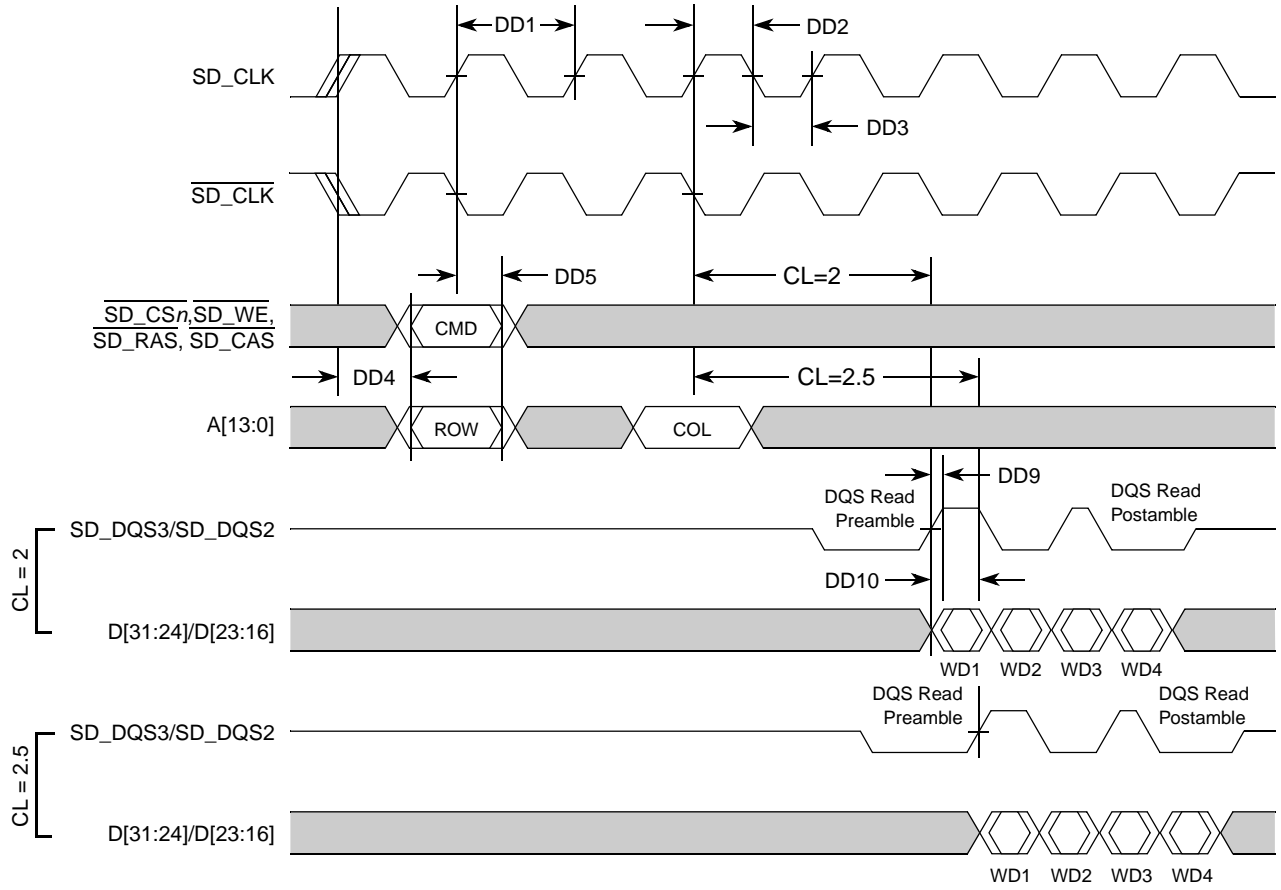


Figure 14. DDR Read Timing

Table 16. DDR Clock Crossover Specifications

| Symbol    | Characteristic   | Min  | Max             | Unit |
|-----------|--|------|-----------------|------|
| $V_{MP}$  | Clock output mid-point voltage                         | 1.05 | 1.45            | V    |
| $V_{OUT}$ | Clock output voltage level                             | -0.3 | $SD\_VDD + 0.3$ | V    |
| $V_{ID}$  | Clock output differential voltage (peak to peak swing) | 0.7  | $SD\_VDD + 0.6$ | V    |
| $V_{IX}$  | Clock crossing point voltage <sup>1</sup>              | 1.05 | 1.45            | V    |

<sup>1</sup> The clock crossover voltage is only guaranteed when using the highest drive strength option for the SDCLK[1:0] and SDCLK[1:0] signals.

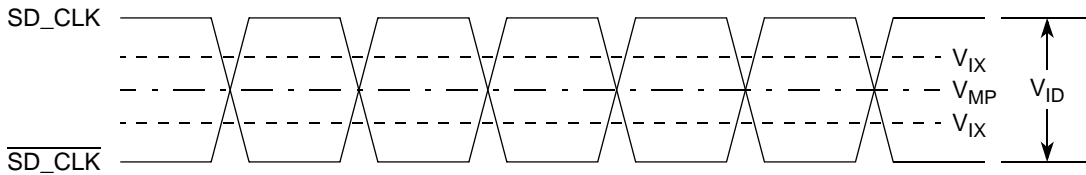


Figure 15. SD\_CLK and  $\overline{SD\_CLK}$  Crossover Timing

## 5.8 General Purpose I/O Timing

 Table 17. GPIO Timing<sup>1</sup>

| Num | Characteristic                     | Symbol      | Min | Max | Unit |
|-----|------------------------------------|-------------|-----|-----|------|
| G1  | FB_CLK High to GPIO Output Valid   | $t_{CHPOV}$ | —   | 10  | ns   |
| G2  | FB_CLK High to GPIO Output Invalid | $t_{CHPOI}$ | 1.5 | —   | ns   |
| G3  | GPIO Input Valid to FB_CLK High    | $t_{PVCH}$  | 9   | —   | ns   |
| G4  | FB_CLK High to GPIO Input Invalid  | $t_{CHPI}$  | 1.5 | —   | ns   |

<sup>1</sup> These general purpose specifications apply to the following signals:  $\overline{IRQn}$ , all UART signals, FlexCAN signals, PWM signals,  $\overline{DACKn}$  and  $\overline{DREQn}$ , and all signals configured as GPIO.

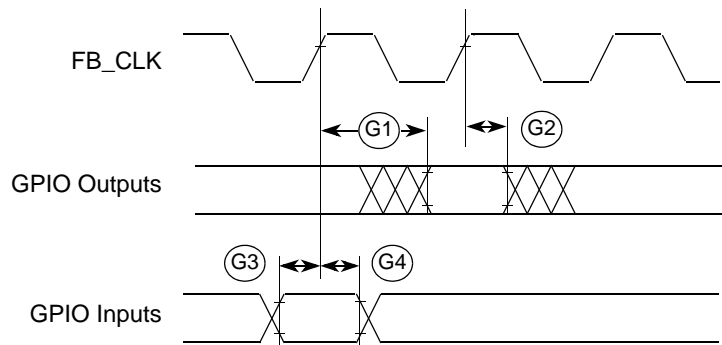


Figure 16. GPIO Timing

## 5.9 Reset and Configuration Override Timing

Table 18. Reset and Configuration Override Timing

| Num | Characteristic   | Symbol      | Min | Max | Unit      |
|-----|--|-------------|-----|-----|-----------|
| R1  | $\overline{RESET}$ Input valid to FB_CLK High                        | $t_{RVCH}$  | 9   | —   | ns        |
| R2  | FB_CLK High to $\overline{RESET}$ Input invalid                      | $t_{CHRI}$  | 1.5 | —   | ns        |
| R3  | $\overline{RESET}$ Input valid Time <sup>1</sup>                     | $t_{RIVT}$  | 5   | —   | $t_{CYC}$ |
| R4  | FB_CLK High to $\overline{RSTOUT}$ Valid                             | $t_{CHROV}$ | —   | 10  | ns        |
| R5  | $\overline{RSTOUT}$ valid to Config. Overrides valid                 | $t_{ROVCV}$ | 0   | —   | ns        |
| R6  | Configuration Override Setup Time to $\overline{RSTOUT}$ invalid     | $t_{COS}$   | 20  | —   | $t_{CYC}$ |
| R7  | Configuration Override Hold Time after $\overline{RSTOUT}$ invalid   | $t_{COH}$   | 0   | —   | ns        |
| R8  | $\overline{RSTOUT}$ invalid to Configuration Override High Impedance | $t_{ROICZ}$ | —   | 1   | $t_{CYC}$ |

<sup>1</sup> During low power STOP, the synchronizers for the  $\overline{RESET}$  input are bypassed and  $\overline{RESET}$  is asserted asynchronously to the system. Thus,  $\overline{RESET}$  must be held a minimum of 100 ns.

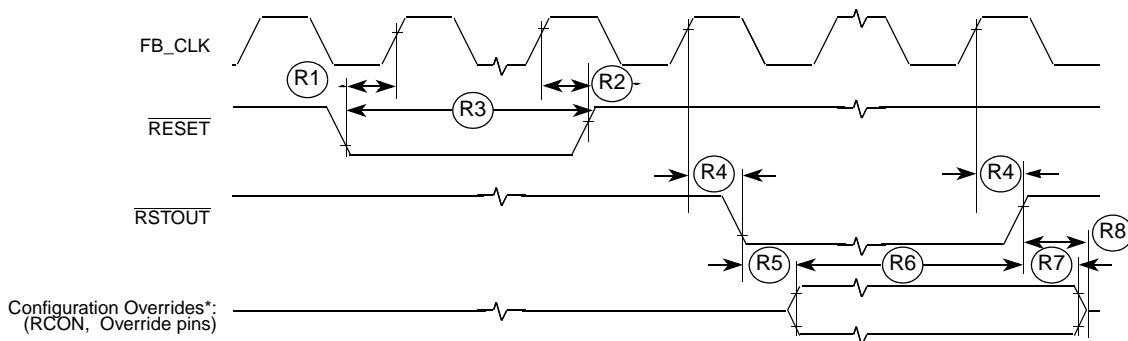


Figure 17.  $\overline{\text{RESET}}$  and Configuration Override Timing

**NOTE**

Refer to the CCM chapter of the *MCF52277 Reference Manual* for more information.

### 5.10 LCD Controller Timing Specifications

This sections lists the timing specifications for the LCD Controller.

Table 19. LCD\_LSCLK Timing

| Num | Characteristic        | Min | Max  | Unit |
|-----|-----------------------|-----|------|------|
| T1  | LCD_LSCLK Period      | 25  | 2000 | ns   |
| T2  | Pixel data setup time | 11  | —    | ns   |
| T3  | Pixel data up time    | 11  | —    | ns   |

**Note:** The pixel clock is equal to  $\text{LCD\_LSCLK} / (\text{PCD} + 1)$ . When it is in CSTN, TFT, or monochrome mode with bus width = 1, LCD\_LSCLK is equal to the pixel clock. When it is in monochrome with other bus width settings, LCD\_LSCLK is equal to the pixel clock divided by bus width. The polarity of LCD\_LSCLK and LCD\_D signals can also be programmed.

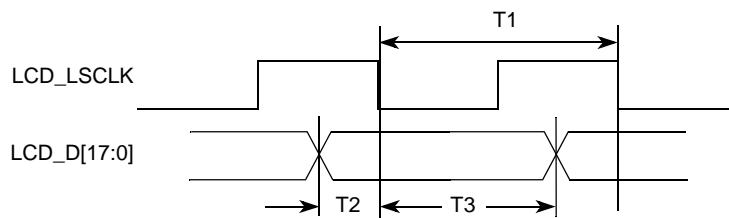


Figure 18. LCD\_LSCLK to LCD\_D[17:0] timing diagram

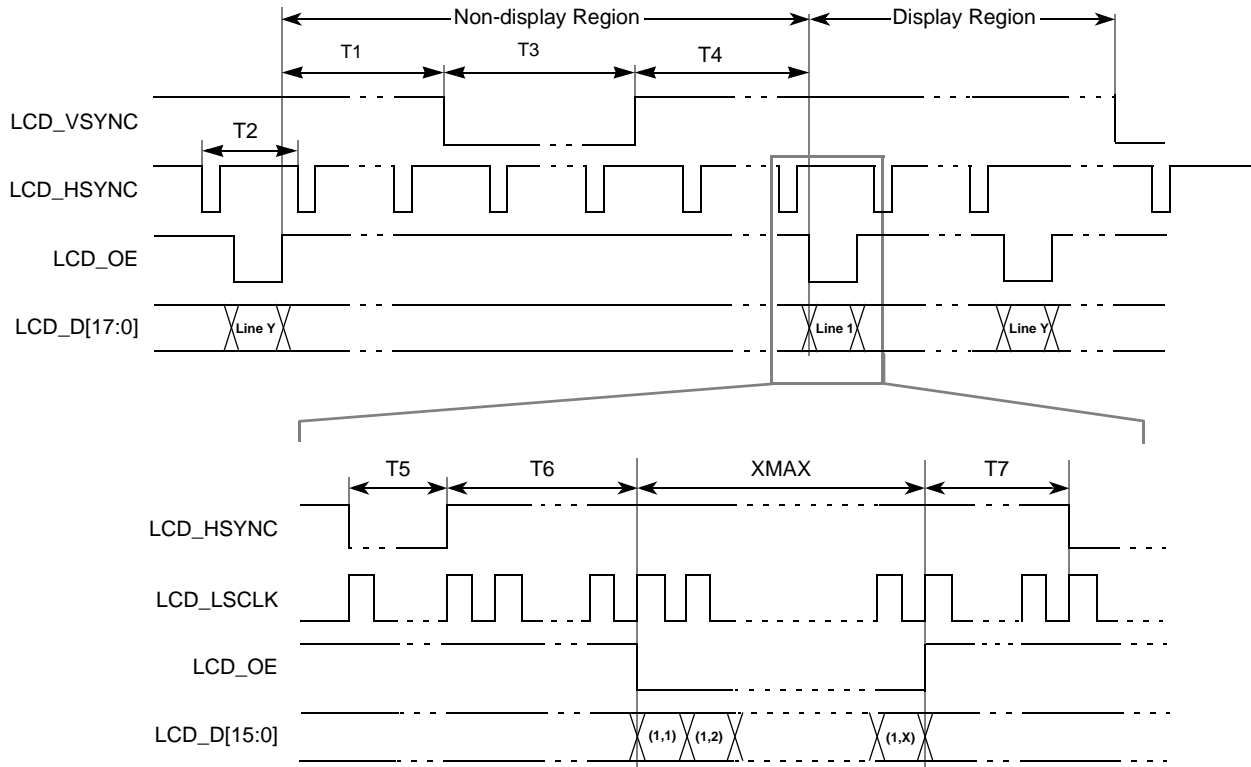


Figure 19. 4/8/12/16/18 Bit/Pixel TFT Color Mode Panel Timing

Table 20. 4/8/12/16/18 Bit/Pixel TFT Color Mode Panel Timing

| Num | Characteristic                          | Min                | Value                                   | Unit |
|-----|---|--------------------|---|------|
| T1  | End of LCD_OE to beginning of LCD_VSYNC | $T5 + T6 + T7 - 1$ | $(VWAIT1 \times T2) + T5 + T6 + T7 - 1$ | Ts   |
| T2  | LCD_HSYNC period                        | —                  | $XMAX + T5 + T6 + T7$                   | Ts   |
| T3  | LCD_VSYNC pulse width                   | T2                 | $VWIDTH \times T2$                      | Ts   |
| T4  | End of LCD_VSYNC to beginning of LCD_OE | 1                  | $(VWAIT2 \times T2) + 1$                | Ts   |
| T5  | LCD_HSYNC pulse width                   | 1                  | $HWIDTH + 1$                            | Ts   |
| T6  | End of LCD_HSYNC to beginning to LCD_OE | 3                  | $HWAIT2 + 3$                            | Ts   |
| T7  | End of LCD_OE to beginning of LCD_HSYNC | 1                  | $HWAIT1 + 1$                            | Ts   |

**Note:** Ts is the LCD\_LSCLK period. LCD\_VSYNC, LCD\_HSYNC, and LCD\_OE can be programmed as active high or active low. In Figure 19, all 3 signals are active low. LCD\_LSCLK can be programmed to be deactivated during the LCD\_VSYNC pulse or the LCD\_OE deasserted period. In Figure 19, LCD\_LSCLK is always active.

**Note:** XMAX is defined in number of pixels in one line.

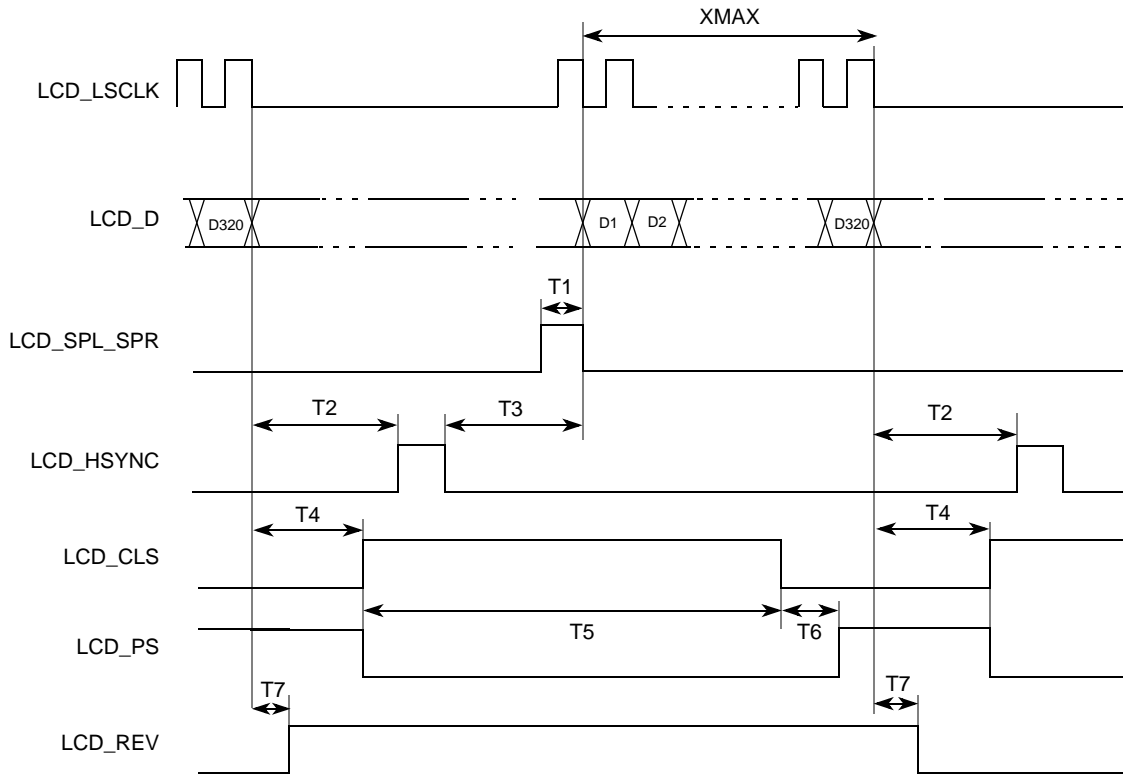


Figure 20. Sharp TFT Panel Timing

Table 21. Sharp TFT Panel Timing

| Num | Characteristic                                 | Min | Value              | Unit |
|-----|--|-----|--------------------|------|
| T1  | LCD_SPL/LCD_SPR pulse width                    | —   | 1                  | Ts   |
| T2  | End of LCD_D of line to beginning of LCD_HSYNC | 1   | HWAIT1+1           | Ts   |
| T3  | End of LCD_HSYNC to beginning of LCD_D of line | 4   | HWAIT2 + 4         | Ts   |
| T4  | LCD_CLS rise delay from end of LCD_D of line   | 3   | CLS_RISE_DELAY+1   | Ts   |
| T5  | LCD_CLS pulse width                            | 1   | CLS_HI_WIDTH+1     | Ts   |
| T6  | LCD_PS rise delay from LCD_CLS negation        | 0   | PS_RISE_DELAY      | Ts   |
| T7  | LCD_REV toggle delay from last LCD_D of line   | 1   | REV_TOGGLE_DELAY+1 | Ts   |

**Note:** Falling of LCD\_SPL/LCD\_SPR aligns with first LCD\_D of line.

**Note:** Falling of LCD\_PS aligns with rising edge of LCD\_CLS.

**Note:** LCD\_REV toggles in every LCD\_HSYN period.



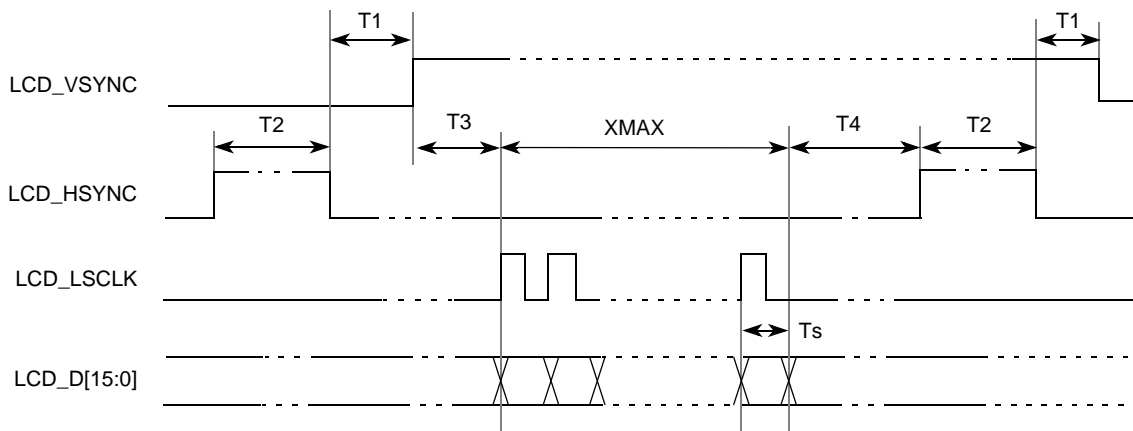


Figure 21. Non-TFT Mode Panel Timing

Table 22. Non-TFT Mode Panel Timing

| Num | Characteristic               | Min | Value               | Unit |
|-----|------------------------------|-----|---------------------|------|
| T1  | LCD_HSYNC to LCD_VSYNC delay | 2   | HWAIT2 + 2          | Tpix |
| T2  | LCD_HSYNC pulse width        | 1   | HWIDTH + 1          | Tpix |
| T3  | LCD_VSYNC to LCD_LSCLK       | —   | $0 \leq T3 \leq Ts$ | —    |
| T4  | LCD_LSCLK to LCD_HSYNC       | 1   | HWAIT1 + 1          | Tpix |

**Note:** Ts is the LCD\_LSCLK period while Tpix is the pixel clock period. LCD\_VSYNC, LCD\_HSYNC, and LCD\_LSCLK can be programmed as active high or active low. In Figure 21, all these 3 signals are active high. When it is in CSTN mode or monochrome mode with bus width = 1,  $T3 = Tpix = Ts$ . When it is in monochrome mode with bus width = 2, 4 and 8,  $T3 = 1, 2$  and  $4 Tpix$  respectively.

## 5.11 USB On-The-Go Specifications

The MCF5227x device is compliant with industry standard USB 2.0 specification.

Table 23. USB On-Chip Transceiver DC Characteristics

| Characteristic                  | Condition | Symbol      | Min | Typ | Max | Unit |
|---------------------------------|-----------|-------------|-----|-----|-----|------|
| Input High                      | Driven    | $V_{IH}$    | 2.0 | —   | —   | V    |
| Input Low                       |           | $V_{IL}$    | —   | —   | 0.8 | V    |
| Input Differential              | (DP – DM) | $V_{ID}$    | 200 | —   | 00  | mV   |
| Differential Common Mode Range  |           | $V_{CM}$    | 0.8 | —   | 2.5 | V    |
| Single Ended Receive Threshold  |           | $V_{SETHR}$ | 0.8 | —   | 2.0 | V    |
| Single Ended Receive Hysteresis |           | $V_{SEHYS}$ | —   | 400 | —   | mV   |
| Output High                     | Driven    | $V_{OH}$    | 0.0 | —   | 300 | mV   |
| Output Low                      | Driven    | $V_{OL}$    | 2.8 | —   | 2.0 | V    |
| Differential Output Crossover   | DP = DM   | $V_{CRS}$   | 1.3 | —   | 2.0 | V    |

**Table 23. USB On-Chip Transceiver DC Characteristics (continued)**

| Characteristic                   | Condition | Symbol                | Min  | Typ  | Max   | Unit     |
|----------------------------------|-----------|-----------------------|------|------|-------|----------|
| P side Impedance                 | Driven    | $Z_P$                 | 6.25 | 8.25 | 11.25 | $\Omega$ |
| M side Impedance                 | Driven    | $Z_M$                 | 6.25 | 8.25 | 11.25 | $\Omega$ |
| Impedance Matching P/M           |           | $Z_{\text{Matching}}$ | —    | 0.17 | 0.23  | $\Omega$ |
| Pulldown Resistance <sup>1</sup> |           | $R_{PD}$              | 30k  | 50k  | 70k   | $\Omega$ |

<sup>1</sup> The pulldown resistors are included to provide a method to keep DP and DM signals in a known quiescent state if desired when the USB port is not being used or when the USB cable is not connected. These on-chip resistors should not be used to provide the 15-k $\Omega$  host-mode pulldowns called for in Chapter 7 of the USB Specification, Rev. 1.1 or Rev. 2.0.

**Table 24. USB On-Chip Transceiver Full Speed AC Characteristics**

| Characteristic                | Condition | Symbol                             | Min | Typ | Max  | Unit |
|-------------------------------|-----------|------------------------------------|-----|-----|------|------|
| Rise Time                     | 10–90%    | $t_{LH}$                           | 7   | 11  | 17.5 | ns   |
| Fall Time                     | 90–10%    | $t_{HL}$                           | 7   | 11  | 17.5 | ns   |
| Rise/Fall Matching            | —         | $\frac{t_{LH}}{t_{HL}}$ Matching   | 20  | 40  | 60   | ps   |
| Rise/Fall Matching, DP and DM | —         | $\frac{t_{LH}}{t_{HL}}$ Pad-to-Pad | 330 | 360 | 640  | ps   |
| Time Skew Between DP and DM   | —         | $t_{SKE}$                          | 100 | 140 | 210  | ps   |

**Table 25. USB On-Chip Transceiver Low Speed AC Characteristics**

| Characteristic     | Condition               | Symbol                           | Min | Typ | Max | Unit |
|--------------------|-------------------------|----------------------------------|-----|-----|-----|------|
| Rise Time          | 10–90%                  | $t_{LH}$                         | 75  | —   | 300 | ns   |
| Fall Time          | 90–10%                  | $t_{HL}$                         | 75  | —   | 300 | ns   |
| Rise/Fall Matching | $\frac{t_{LH}}{t_{HL}}$ | $\frac{t_{LH}}{t_{HL}}$ Matching | 80  | —   | 125 | %    |

## 5.12 SSI Timing Specifications

This section provides the AC timings for the SSI in master (clocks driven) and slave modes (clocks input). All timings are given for non-inverted serial clock polarity (SSI\_TCR[TSCPK] = 0, SSI\_RCR[RSCKP] = 0) and a non-inverted frame sync (SSI\_TCR[TFSI] = 0, SSI\_RCR[RFSI] = 0). If the polarity of the clock and/or the frame sync have been inverted, all the timings remain valid by inverting the clock signal (SSI\_BCLK) and/or the frame sync (SSI\_FS) shown in the figures below.

**Table 26. SSI Timing—Master Modes<sup>1</sup>**

| Num | Characteristic                  | Symbol     | Min                  | Max | Unit       | Notes        |
|-----|---------------------------------|------------|----------------------|-----|------------|--------------|
| S1  | SSI_MCLK cycle time             | $t_{MCLK}$ | $4 \times 1/f_{SYS}$ | —   | ns         | <sup>2</sup> |
| S2  | SSI_MCLK pulse width high / low |            | 45%                  | 55% | $t_{MCLK}$ |              |
| S3  | SSI_BCLK cycle time             | $t_{BCLK}$ | $4 \times 1/f_{SYS}$ | —   | ns         | <sup>3</sup> |
| S4  | SSI_BCLK pulse width            |            | 45%                  | 55% | $t_{BCLK}$ |              |

**Table 26. SSI Timing—Master Modes<sup>1</sup> (continued)**

| Num | Characteristic                               | Symbol | Min | Max | Unit | Notes |
|-----|--|--------|-----|-----|------|-------|
| S5  | SSI_BCLK to SSI_FS output valid              |        | —   | 10  | ns   |       |
| S6  | SSI_BCLK to SSI_FS output invalid            |        | 0   | —   | ns   |       |
| S7  | SSI_BCLK to SSI_TXD valid                    |        | —   | 10  | ns   |       |
| S8  | SSI_BCLK to SSI_TXD invalid / high impedance |        | 0   | —   | ns   |       |
| S9  | SSI_RXD / SSI_FS input setup before SSI_BCLK |        | 10  | —   | ns   |       |
| S10 | SSI_RXD / SSI_FS input hold after SSI_BCLK   |        | 0   | —   | ns   |       |

<sup>1</sup> All timings specified with a capacitive load of 25pF.

<sup>2</sup> SSI\_MCLK can be generated from SSI\_CLKIN or a divided version of the internal system clock (SYSCLK).

<sup>3</sup> SSI\_BCLK can be derived from SSI\_CLKIN or a divided version of SYSCLK. If the SYSCLK is used, the minimum divider is 6. If the SSI\_CLKIN input is used, the programmable dividers must be set to ensure that SSI\_BCLK does not exceed  $4 \times f_{\text{SYS}}$ .

**Table 27. SSI Timing—Slave Modes<sup>1</sup>**

| Num | Characteristic   | Symbol            | Min                         | Max | Unit              | Notes |
|-----|--|-------------------|-----------------------------|-----|-------------------|-------|
| S11 | SSI_BCLK cycle time  | $t_{\text{BCLK}}$ | $4 \times 1/f_{\text{SYS}}$ | —   | ns                |       |
| S12 | SSI_BCLK pulse width high / low                              |                   | 45%                         | 55% | $t_{\text{BCLK}}$ |       |
| S13 | SSI_FS input setup before SSI_BCLK                           |                   | 10                          | —   | ns                |       |
| S14 | SSI_FS input hold after SSI_BCLK                             |                   | 2                           | —   | ns                |       |
| S15 | SSI_BCLK to SSI_TXD / SSI_FS output valid                    |                   | —                           | 10  | ns                |       |
| S16 | SSI_BCLK to SSI_TXD / SSI_FS output invalid / high impedance |                   | 0                           | —   | ns                |       |
| S17 | SSI_RXD setup before SSI_BCLK                                |                   | 10                          | —   | ns                |       |
| S18 | SSI_RXD hold after SSI_BCLK                                  |                   | 2                           | —   | ns                |       |

<sup>1</sup> All timings specified with a capacitive load of 25 pF.

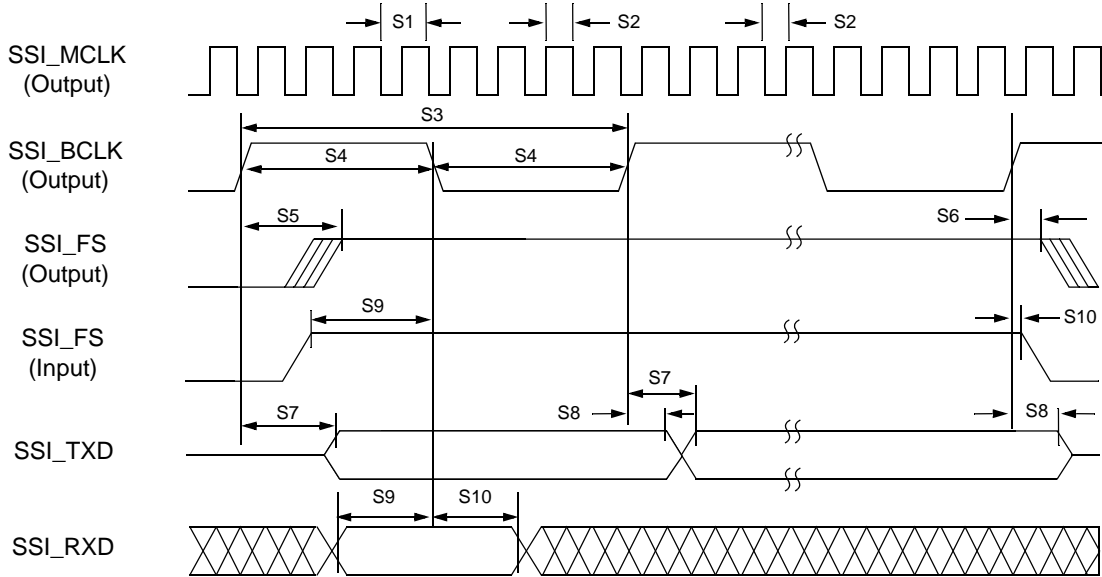


Figure 22. SSI Timing—Master Modes

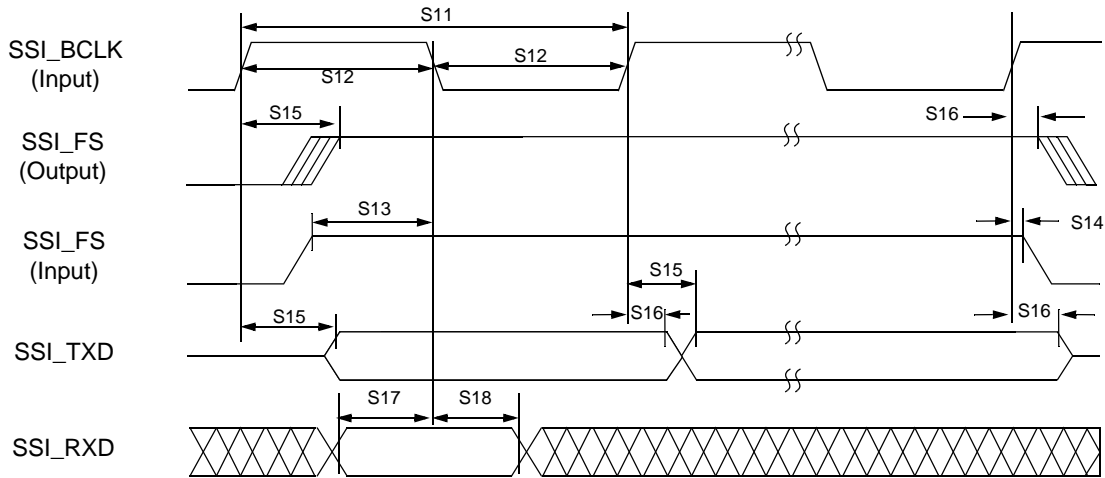


Figure 23. SSI Timing—Slave Modes

### 5.13 I<sup>2</sup>C Timing Specifications

Table 28 lists specifications for the I<sup>2</sup>C input timing parameters shown in Figure 24.

Table 28. I<sup>2</sup>C Input Timing Specifications between SCL and SDA

| Num | Characteristic   | Min | Max | Unit             |
|-----|--|-----|-----|------------------|
| I1  | Start condition hold time  | 2   | —   | t <sub>cyc</sub> |
| I2  | Clock low period   | 8   | —   | t <sub>cyc</sub> |
| I3  | I2C_SCL/I2C_SDA rise time (V <sub>IL</sub> = 0.5 V to V <sub>IH</sub> = 2.4 V) | —   | 1   | ms               |
| I4  | Data hold time   | 0   | —   | ns               |

**Table 28. I<sup>2</sup>C Input Timing Specifications between SCL and SDA (continued)**

| Num | Characteristic   | Min | Max | Unit      |
|-----|--|-----|-----|-----------|
| I5  | I2C_SCL/I2C_SDA fall time ( $V_{IH} = 2.4\text{ V}$ to $V_{IL} = 0.5\text{ V}$ ) | —   | 1   | ms        |
| I6  | Clock high time  | 4   | —   | $t_{cyc}$ |
| I7  | Data setup time  | 0   | —   | ns        |
| I8  | Start condition setup time (for repeated start condition only)                   | 2   | —   | $t_{cyc}$ |
| I9  | Stop condition setup time  | 2   | —   | $t_{cyc}$ |

Table 29 lists specifications for the I<sup>2</sup>C output timing parameters shown in Figure 24.

**Table 29. I<sup>2</sup>C Output Timing Specifications between SCL and SDA**

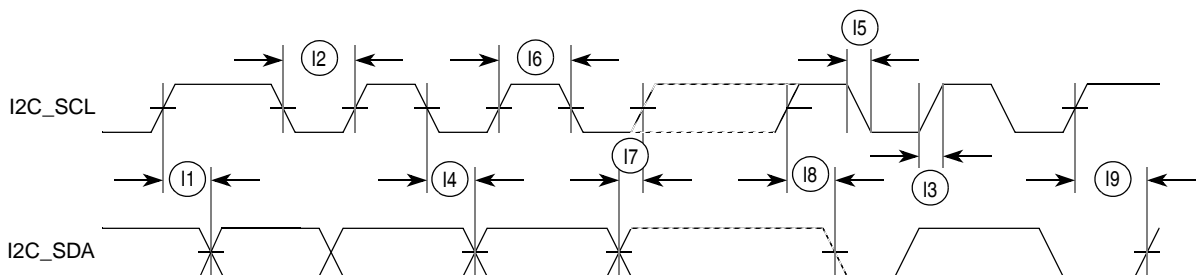
| Num             | Characteristic   | Min | Max | Unit          |
|-----------------|--|-----|-----|---------------|
| I1 <sup>1</sup> | Start condition hold time  | 6   | —   | $t_{cyc}$     |
| I2 <sup>1</sup> | Clock low period   | 10  | —   | $t_{cyc}$     |
| I3 <sup>2</sup> | I2C_SCL/I2C_SDA rise time ( $V_{IL} = 0.5\text{ V}$ to $V_{IH} = 2.4\text{ V}$ ) | —   | —   | $\mu\text{s}$ |
| I4 <sup>1</sup> | Data hold time   | 7   | —   | $t_{cyc}$     |
| I5 <sup>3</sup> | I2C_SCL/I2C_SDA fall time ( $V_{IH} = 2.4\text{ V}$ to $V_{IL} = 0.5\text{ V}$ ) | —   | 3   | ns            |
| I6 <sup>1</sup> | Clock high time  | 10  | —   | $t_{cyc}$     |
| I7 <sup>1</sup> | Data setup time  | 2   | —   | $t_{cyc}$     |
| I8 <sup>1</sup> | Start condition setup time (for repeated start condition only)                   | 20  | —   | $t_{cyc}$     |
| I9 <sup>1</sup> | Stop condition setup time  | 10  | —   | $t_{cyc}$     |

<sup>1</sup> Output numbers depend on the value programmed into the IFDR; an IFDR programmed with the maximum frequency (IFDR = 0x20) results in minimum output timings as shown in Table 29. The I<sup>2</sup>C interface is designed to scale the actual data transition time to move it to the middle of the SCL low period. The actual position is affected by the prescale and division values programmed into the IFDR; however, the numbers given in Table 29 are minimum values.

<sup>2</sup> Because I2C\_SCL and I2C\_SDA are open-collector-type outputs, which the processor can only actively drive low, the time I2C\_SCL or I2C\_SDA take to reach a high level depends on external signal capacitance and pull-up resistor values.

<sup>3</sup> Specified at a nominal 50-pF load.

Figure 24 shows timing for the values in Table 29 and Table 28.


**Figure 24. I<sup>2</sup>C Input/Output Timings**

## 5.14 DMA Timer Timing Specifications

Table 30 lists timer module AC timings.

**Table 30. Timer Module AC Timing Specifications**

| Num | Characteristic                            | Min | Max | Unit             |
|-----|---|-----|-----|------------------|
| T1  | DT0IN / DT1IN / DT2IN / DT3IN cycle time  | 3   | —   | t <sub>CYC</sub> |
| T2  | DT0IN / DT1IN / DT2IN / DT3IN pulse width | 1   | —   | t <sub>CYC</sub> |

## 5.15 DSPI Timing Specifications

The DMA Serial Peripheral Interface (DSPI) provides a synchronous serial bus with both master and slave operations. Many of the transfer attributes are programmable. Table 31 provides DSPI timing characteristics for classic SPI timing modes. Refer to the DSPI chapter of the *MCF52277 Reference Manual* for information on the modified transfer formats used for communicating with slower peripheral devices.

**Table 31. DSPI Module AC Timing Specifications<sup>1</sup>**

| Num                | Characteristic   | Symbol           | Min                          | Max                      | Unit | Notes |
|--------------------|--|------------------|------------------------------|--------------------------|------|-------|
| DS1                | DSPI_SCK Cycle Time                                    | t <sub>SCK</sub> | $4 \times 1/f_{SYS}$         | —                        | ns   | 2     |
| DS2                | DSPI_SCK Duty Cycle                                    | —                | $(t_{SCK} \div 2) - 2.0$     | $(t_{SCK} \div 2) + 2.0$ | ns   |       |
| <b>Master Mode</b> |  |                  |                              |                          |      |       |
| DS3                | DSPI_PCS <sub>n</sub> to DSPI_SCK delay                | t <sub>CSC</sub> | $(2 \times 1/f_{SYS}) - 2.0$ | —                        | ns   | 3     |
| DS4                | DSPI_SCK to DSPI_PCS <sub>n</sub> delay                | t <sub>ASC</sub> | $(2 \times 1/f_{SYS}) - 3.0$ | —                        | ns   | 4     |
| DS5                | DSPI_SCK to DSPI_SOUT valid                            | —                | —                            | 5                        | ns   |       |
| DS6                | DSPI_SCK to DSPI_SOUT invalid                          | —                | -5                           | —                        | ns   |       |
| DS7                | DSPI_SIN to DSPI_SCK input setup                       | —                | 9                            | —                        | ns   |       |
| DS8                | DSPI_SCK to DSPI_SIN input hold                        | —                | 0                            | —                        | ns   |       |
| <b>Slave Mode</b>  |  |                  |                              |                          |      |       |
| DS9                | DSPI_SCK to DSPI_SOUT valid                            | —                | —                            | 4                        | ns   |       |
| DS10               | DSPI_SCK to DSPI_SOUT invalid                          | —                | 0                            | —                        | ns   |       |
| DS11               | DSPI_SIN to DSPI_SCK input setup                       | —                | 2                            | —                        | ns   |       |
| DS12               | DSPI_SCK to DSPI_SIN input hold                        | —                | 7                            | —                        | ns   |       |
| DS13               | $\overline{DSPI\_SS}$ active to DSPI_SOUT driven       | —                | —                            | 20                       | ns   |       |
| DS14               | $\overline{DSPI\_SS}$ inactive to DSPI_SOUT not driven | —                | —                            | 18                       | ns   |       |

<sup>1</sup> Timings shown are for DMCR[MTE] = 0 (classic SPI) and DCTAR<sub>n</sub>[CPHA] = 0. Data is sampled on the DSPI\_SIN pin on the odd-numbered DSPI\_SCK edges and driven on the DSPI\_SOUT pin on even-numbered DSPI edges.

<sup>2</sup> When in master mode, the baud rate is programmable in DCTAR<sub>n</sub>[PBR] and DCTAR<sub>n</sub>[BR].

<sup>3</sup> The DSPI\_PCS<sub>n</sub> to DSPI\_SCK delay is programmable in DCTAR<sub>n</sub>[PCSSCK] and DCTAR<sub>n</sub>[CSSCK].

<sup>4</sup> The DSPI\_SCK to DSPI\_PCS<sub>n</sub> delay is programmable in DCTAR<sub>n</sub>[PASC] and DCTAR<sub>n</sub>[ASC].

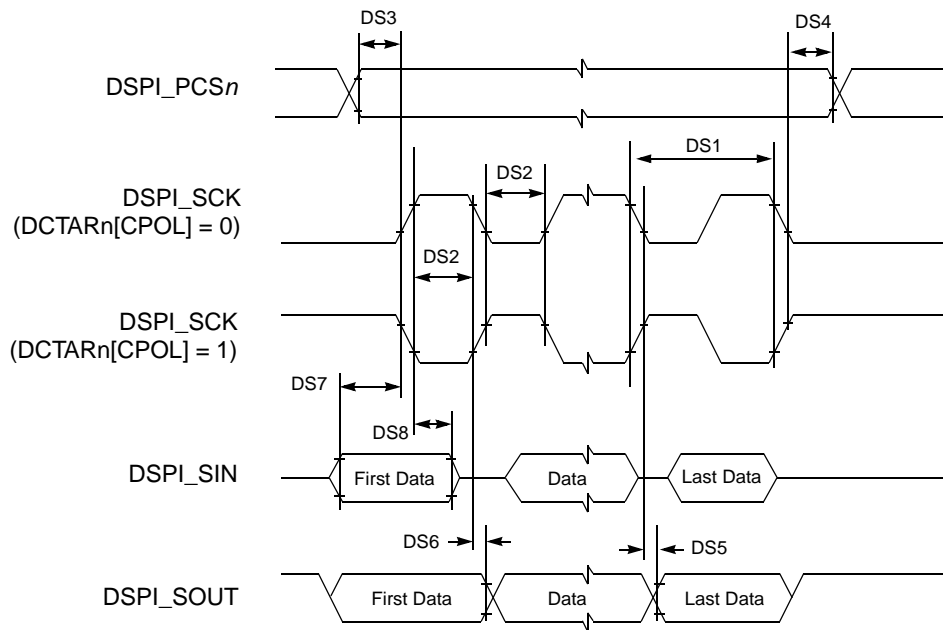


Figure 25. DSPI Classic SPI Timing—Master Mode

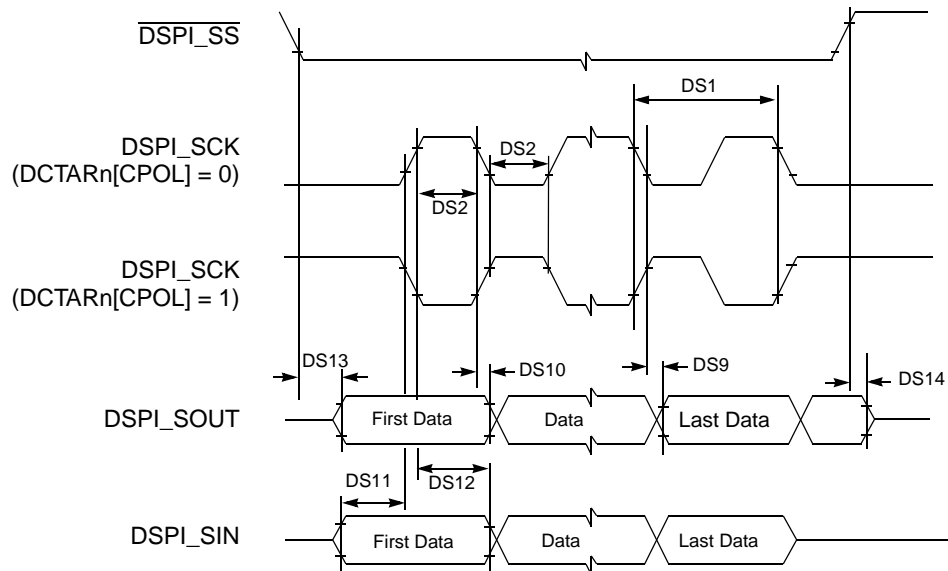


Figure 26. DSPI Classic SPI Timing—Slave Mode

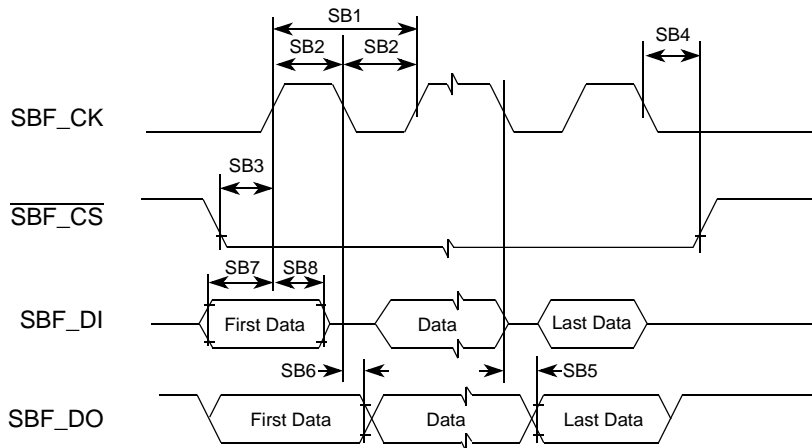
## 5.16 SBF Timing Specifications

The Serial Boot Facility (SBF) provides a means to read configuration information and system boot code from a broad array of SPI-compatible EEPROMs, flashes, FRAMs, nVSRAMs, etc. [Table 32](#) provides the AC timing specifications for the SBF.

**Table 32. SBF AC Timing Specifications**

| Num | Characteristic                              | Symbol      | Min               | Max | Unit        | Notes |
|-----|---|-------------|-------------------|-----|-------------|-------|
| SB1 | SBF_CK Cycle Time                           | $t_{SBFCK}$ | 30                | —   | ns          | 1     |
| SB2 | SBF_CK High/Low Time                        | —           | 30%               | —   | $t_{SBFCK}$ |       |
| SB3 | $\overline{\text{SBF\_CS}}$ to SBF_CK delay | —           | $t_{SBFCK} - 2.0$ | —   | ns          |       |
| SB4 | SBF_CK to $\overline{\text{SBF\_CS}}$ delay | —           | $t_{SBFCK} - 2.0$ | —   | ns          |       |
| SB5 | SBF_CK to SBF_DO valid                      | —           | —                 | 12  | ns          |       |
| SB6 | SBF_CK to SBF_DO invalid                    | —           | 0                 | —   | ns          |       |
| SB7 | SBF_DI to SBF_SCK input setup               | —           | 6                 | —   | ns          |       |
| SB8 | SBF_CK to SBF_DI input hold                 | —           | 0                 | —   | ns          |       |

<sup>1</sup> At reset, the SBF\_CK cycle time is  $t_{REF} \times 67$ . The first byte of data read from the serial memory contains a divider value that is used to set the SBF\_CK cycle time for the duration of the serial boot process.



**Figure 27. SBF Timing**

## 5.17 JTAG and Boundary Scan Timing Specifications

**Table 33. JTAG and Boundary Scan Timing**

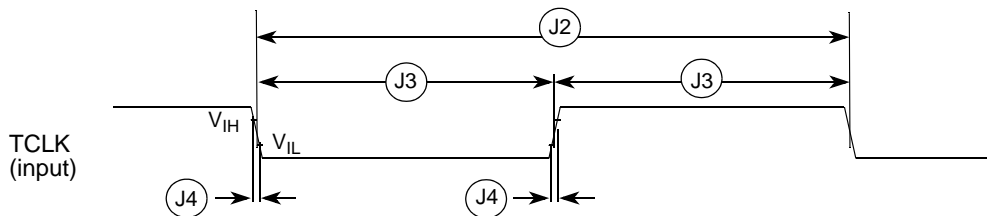
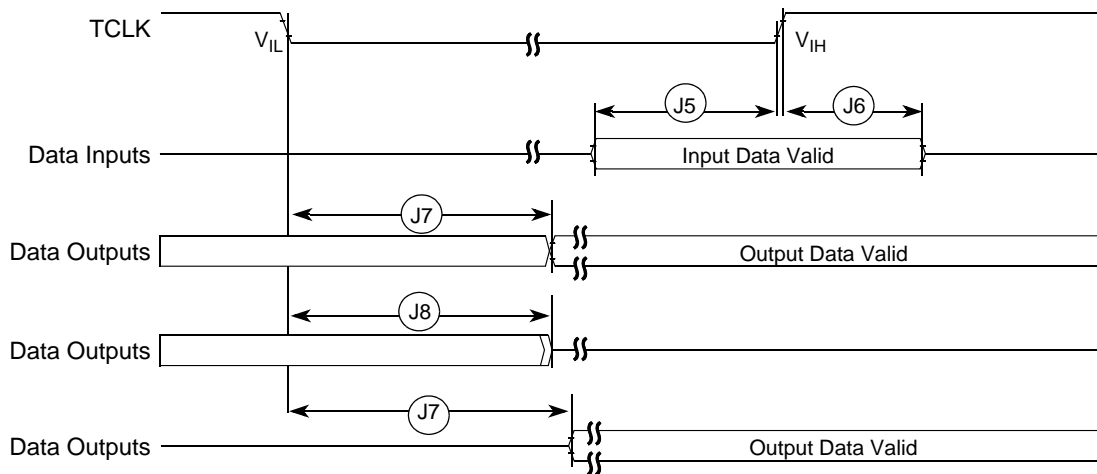
| Num | Characteristic <sup>1</sup>                        | Symbol      | Min | Max | Unit        |
|-----|--|-------------|-----|-----|-------------|
| J1  | TCLK Frequency of Operation                        | $f_{JCYC}$  | DC  | 1/4 | $f_{sys}/2$ |
| J2  | TCLK Cycle Period                                  | $t_{JCYC}$  | 4   | —   | $t_{CYC}$   |
| J3  | TCLK Clock Pulse Width                             | $t_{JCW}$   | 26  | —   | ns          |
| J4  | TCLK Rise and Fall Times                           | $t_{JCRF}$  | 0   | 3   | ns          |
| J5  | Boundary Scan Input Data Setup Time to TCLK Rise   | $t_{BSDST}$ | 4   | —   | ns          |
| J6  | Boundary Scan Input Data Hold Time after TCLK Rise | $t_{BSDHT}$ | 26  | —   | ns          |
| J7  | TCLK Low to Boundary Scan Output Data Valid        | $t_{BSDV}$  | 0   | 33  | ns          |
| J8  | TCLK Low to Boundary Scan Output High Z            | $t_{BSDZ}$  | 0   | 33  | ns          |



**Table 33. JTAG and Boundary Scan Timing (continued)**

| Num | Characteristic <sup>1</sup>                          | Symbol       | Min | Max | Unit |
|-----|--|--------------|-----|-----|------|
| J9  | TMS, TDI Input Data Setup Time to TCLK Rise          | $t_{TAPBST}$ | 4   | —   | ns   |
| J10 | TMS, TDI Input Data Hold Time after TCLK Rise        | $t_{TAPBHT}$ | 10  | —   | ns   |
| J11 | TCLK Low to TDO Data Valid                           | $t_{TDODV}$  | 0   | 26  | ns   |
| J12 | TCLK Low to TDO High Z                               | $t_{TDODZ}$  | 0   | 8   | ns   |
| J13 | $\overline{TRST}$ Assert Time                        | $t_{TRSTAT}$ | 100 | —   | ns   |
| J14 | $\overline{TRST}$ Setup Time (Negation) to TCLK High | $t_{TRSTST}$ | 10  | —   | ns   |

<sup>1</sup> JTAG\_EN is expected to be a static signal. Hence, specific timing is not associated with it.


**Figure 28. Test Clock Input Timing**

**Figure 29. Boundary Scan (JTAG) Timing**

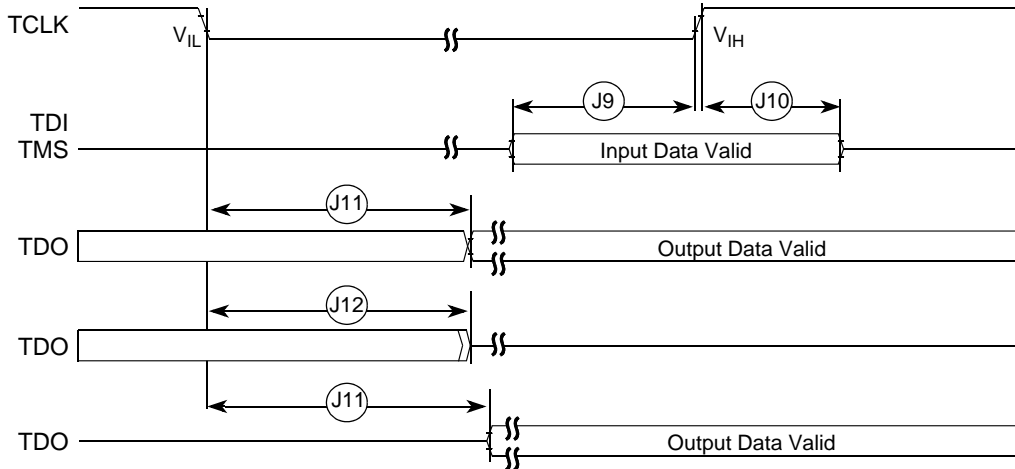


Figure 30. Test Access Port Timing

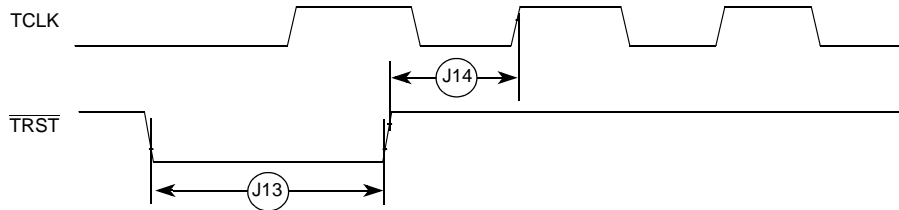


Figure 31.  $\overline{\text{TRST}}$  Timing

## 5.18 Debug AC Timing Specifications

Table 34 lists specifications for the debug AC timing parameters shown in Figure 32.

Table 34. Debug AC Timing Specification

| Num             | Characteristic                    | Min | Max | Units              |
|-----------------|-----------------------------------|-----|-----|--------------------|
| D0              | PSTCLK cycle time                 | 1   | 1   | 1/f <sub>SYS</sub> |
| D1              | PSTCLK rising to PSTDDATA valid   | —   | 3.0 | ns                 |
| D2              | PSTCLK rising to PSTDDATA invalid | 1.5 | —   | ns                 |
| D3              | DSI-to-DSCLK setup                | 1   | —   | PSTCLK             |
| D4 <sup>1</sup> | DSCLK-to-DSO hold                 | 4   | —   | PSTCLK             |
| D5              | DSCLK cycle time                  | 5   | —   | PSTCLK             |
| D6              | BKPT assertion time               | 1   | —   | PSTCLK             |

<sup>1</sup> DSCLK and DSI are synchronized internally. D4 is measured from the synchronized DSCLK input relative to the rising edge of PSTCLK.

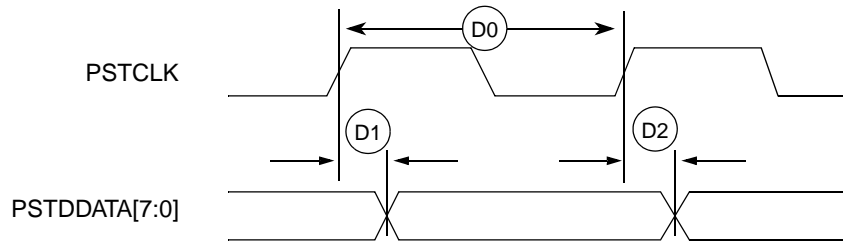


Figure 32. Real-Time Trace AC Timing

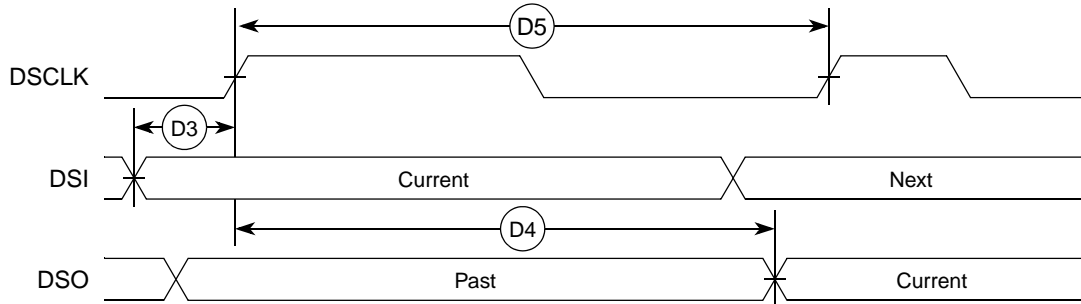


Figure 33. BDM Serial Port AC Timing

## 6 Package Information

The latest package outline drawings are available on the product summary pages on our web site:

<http://www.freescale.com/coldfire>. The following table lists the case outline numbers per device. Use these numbers in the web page's keyword search engine to find the latest package outline drawings.

**Table 35. Package Information**

| Device   | Package Type | Mask Set     | Revision | Case Outline Numbers |
|----------|--------------|--------------|----------|----------------------|
| MCF52274 | 176 LQFP     | All          | All      | 98ASS23479W          |
| MCF52277 | 196 MAPBGA   | M26H         | 1.1      | 98ASH98061A          |
|          |              | 2M26H, 3M26H | 1.2–1.3  | 98ARH98390A          |

## 7 Product Documentation

Documentation is available from a local Freescale distributor, a Freescale sales office, the Freescale Literature Distribution Center, or through the Freescale world-wide web address at <http://www.freescale.com/coldfire>.

# 8 Revision History

Table 36 summarizes revisions to this document.

**Table 36. MCF52277 Data Sheet Revision History**

| Rev. No. | Date of Release | Summary of Changes   |
|----------|-----------------|--|
| 3        | 02/2008         | Initial public revision.   |
| 4        | 05/2008         | Corrected MCF52274 order number from MCF52274CAB120 to MCF52274CLU120 in <a href="#">Table 2</a>   |
| 5        | 07/2008         | Corrected MCF52277CVM166 part number to MCF52277CVM160 in <a href="#">Table 2</a> . Although, this device has a maximum rated frequency of 166.67 MHz.   |
| 6        | 07/2008         | Added data to <a href="#">Section 3.5, "Power Consumption Specifications."</a>   |
| 7        | 02/2009         | <p>Changed document type from Data Sheet: Advance Information to Data Sheet: Technical Data and corresponding footnote on first page</p> <p>Replaced <math>t_{SYS}</math> with <math>1/f_{SYS}</math> throughout</p> <p>Changed the following specs in <a href="#">Table 14</a> and <a href="#">Table 15</a>:</p> <ul style="list-style-type: none"> <li>• Minimum frequency of operation from TBD to 60MHz</li> <li>• Maximum clock period from TBD to 16.67 ns</li> </ul> <p>Added RTC and Oscillator Supply Voltage specs to <a href="#">Table 7</a> and <a href="#">Table 10</a></p> <p>In <a href="#">Table 8</a>:</p> <ul style="list-style-type: none"> <li>• Updated thermal characteristics for the 196 MAPBGA package</li> <li>• Added thermal characteristics for the 176 LQFP package that were TBD</li> </ul> <p>In <a href="#">Table 11</a>:</p> <ul style="list-style-type: none"> <li>• Corrected maximum crystal reference frequency range from 66.67 to 25 MHz</li> <li>• Added footnotes to maximum crystal and external reference frequency ranges</li> <li>• Changed minimum core/system and CLKOUT frequencies from TBD to 512 and 256 Hz, respectively.</li> </ul> <p>In <a href="#">Table 12</a>:</p> <ul style="list-style-type: none"> <li>• Added Typical column</li> <li>• Removed Internal Reference Voltage spec as it isn't necessary</li> <li>• Moved Current Consumption specs from maximum column to typical column</li> <li>• Added INL and DNL specs that were TBD, and changed the unit footnote</li> <li>• Replaced Gain and Offset Error specs with Full-Scale and Zero-Scale Error</li> <li>• Removed Input Leakage Current and Input Current specs as they aren't necessary</li> </ul> <p>Removed Gain Calculations section as it isn't necessary</p> |
| 8        | 09/2009         | In <a href="#">Table 35</a> , added case outline number for MCF52277 masks 2M26H and 3M26H   |



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